µPD166038T1J

INTELLIGENT POWER DEVICE

R07DS1115EJ0201
Rev.2.01
Jul 02, 2015

1. Overview

1.1 Description

Family:

µPD166038T1J is a part of 2nd Generation Intelligent Power Devices (IPD). This is N-channel high-side switch with charge pump, voltage controlled input, diagnostic feedback with proportional load current sense and embedded protection function. Family includes up to 14 devices depending on on-state resistance, package and channel number combination.

Scalability:

Variety of on-state resistance combined with standardized package on pin-out give user high flexibility for unit design depending on target load.

Robustness:

Because of advanced protection method, 2nd Generation Intelligent Power Devices achieve high robustness against long term and repetitive short circuit condition.

1.2 Features

- Built-in charge pump
- 3.3V compatible logic interface
- Low standby current
- Short circuit protection
  - Shutdown by over current detection
  - Power limitation protection by over load detection (Power limitation: current limitation with delta Tch control)
  - Absolute Tch over temperature protection
- Built-in diagnostic function
  - Proportional load current sensing
  - Defined fault signal in case of abnormal load condition
- Loss of ground protection
- Under voltage lock out
- Active clamp operation at inductive load switch off
- Cross current protection in case of H-bridge high side usage
- AEC Qualified
- RoHS compliant

1.3 Application

- Light bulb switching from 35W to 60W, Flasher driver
- Switching of all types of 14V DC grounded loads, such as LED, inductor, resistor and capacitor
- Power supply switch, fail-safe switch of 14V DC grounded system

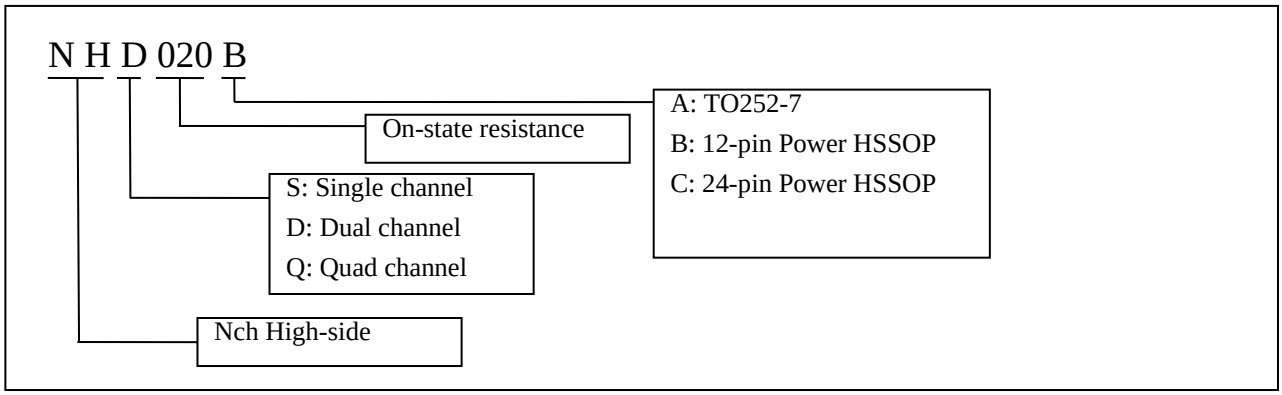
Note: The information contained in this document is the one that was obtained when the document was issued, and may be subject to change.

2. Ordering Information

Part No.	Nick name	Lead plating	Packing	Package
UPD166038T1J-E1-AY	NHD020B	Pure Matte Sn	Tape 1500 p/reel	12-pin Power HSSOP
UPD166038T1J-E2-AY	NHD020B	Pure Matte Sn	Tape 1500 p/reel	12-pin Power HSSOP

Note: MSL: 1, profile acc. J-STD-20C

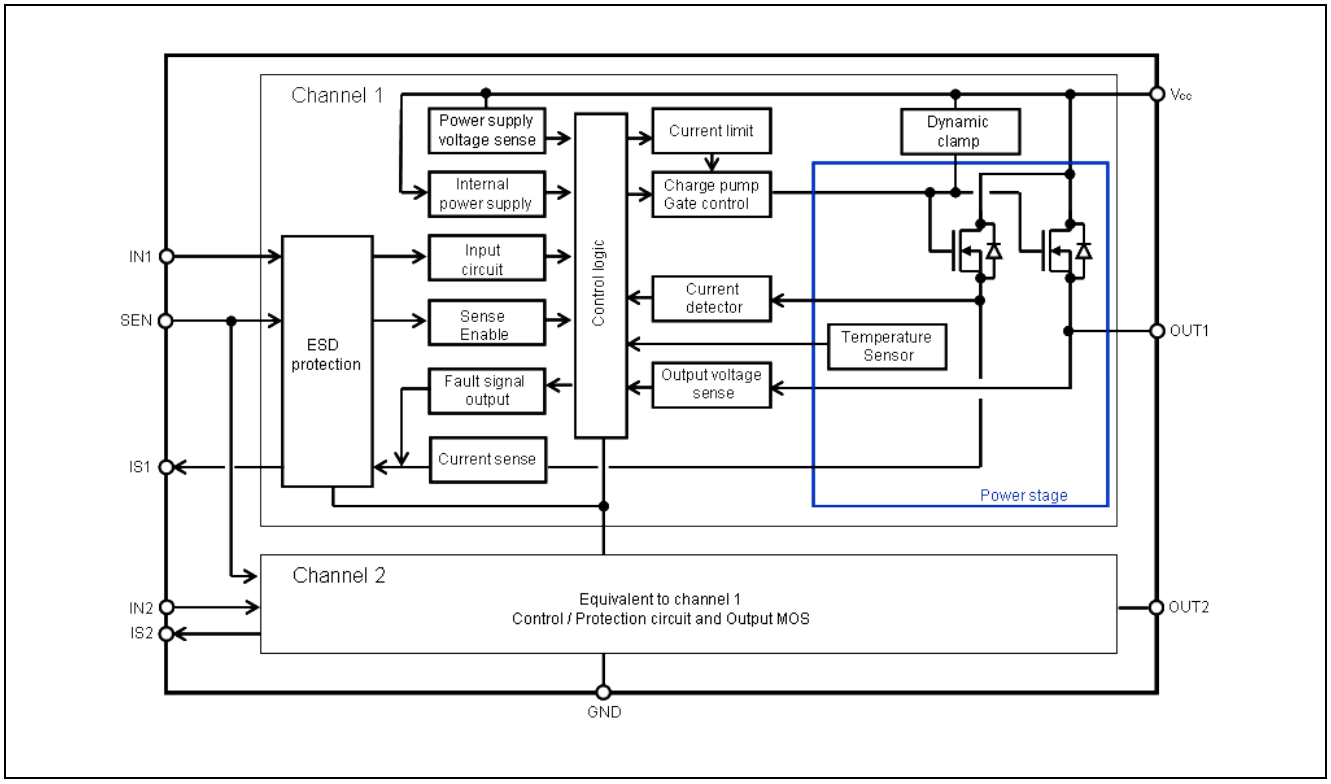
2.1 Nick name



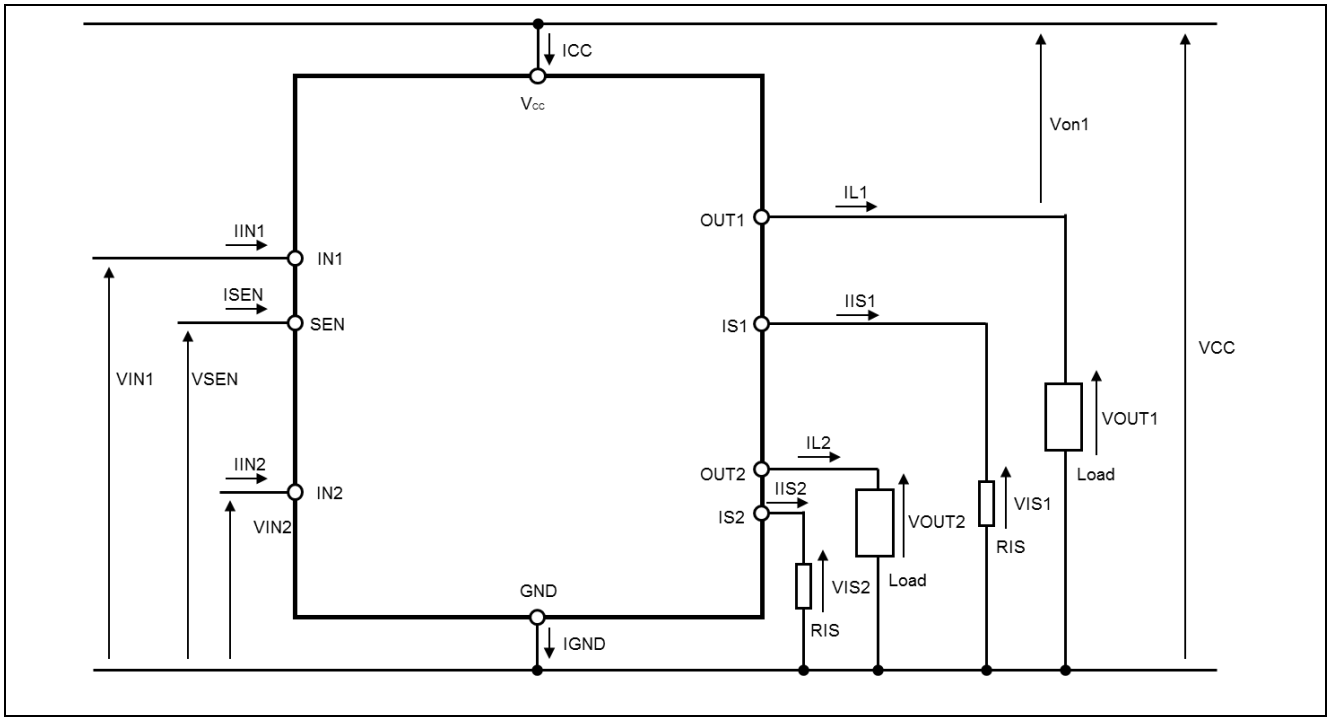
3. Specification

3.1 Block Diagram

3.1.1 Nch High-side Single Device



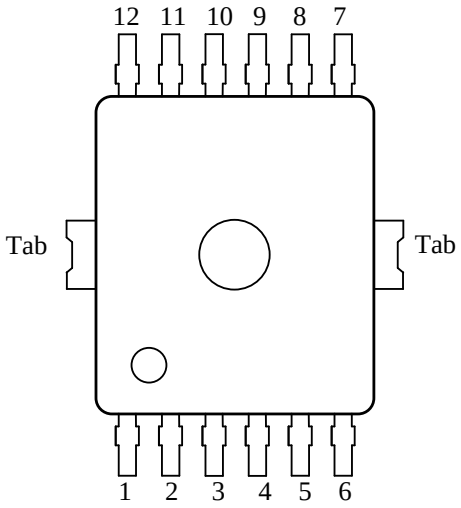
Voltage and Current Definition



3.2 Pin Configuration

3.2.1 12-pin Power HSSOP Pin Configuration

Pin No.	Terminal Name
1	GND
2	IN1
3	IS1
4	IS2
5	IN2
6	VCC
7	SEN
8	OUT2
9	OUT2
10	OUT1
11	OUT1
12	VCC
Tab	VCC



Pin function

Terminal Name	Pin function	Recommended connection
GND	Ground connection	Connected to GND through a 100 Ohm resistor or a diode for reverse current protection Refer chapter 6.
INn	Input signal for channel n (n=1 to 2)	Connected to MCU port through 2k-50K serial resistor
ISn	Current sense and Diagnosis output signal channel n (n=1 to 2)	Connected to GND through a 0.67K-5K resistor
SEN	Sense enable input	Connected to MCU port through 2k-50K serial resistor
OUTn	Protected high-side power output channel n (n=1 to 2)	Connected to load with small 50-100nf capacitor in parallel
VCC	Positive power supply for logic supply as well as output power supply	Connected to battery voltage with small 100nf capacitor in parallel
N.C.	Non connection	Left open

3.3 Absolute Maximum Ratings

Ta=25degreeC, unless other specified

Parameter	Symbol	Rating	Unit	Test Condition		
Vcc Voltage	V_{CC}	28	V			
Vcc Voltage at reverse battery condition	$-V_{CC}$	-16	V	RL=3.4ohm, t<2min, RIN=2kohm, RSEN=2kohm, RIS=1kohm, RGND=100ohm		
GND Reverse current at reverse battery condition	$I_{GND(Rev)}$	200	mA	RL=3.4ohm, t<2min		
Vcc voltage under Load Dump condition	$V_{load\ dump}$	42	V	RI=1ohm, RL=3.4ohm, RIS=1kohm, RIN=2kohm, RSEN=2kohm , RGND=100ohm, td=400ms,		
Load Current	I_L	Self limited	A			
Total power dissipation for whole device (DC)	P_D	1.85	W	Ta=85degreeC, Device on 50mmx50mmx1.5mm epoxy PCB FR4 with 6 cm2 of 70 um copper area		
Voltage at IN pin	V_{IN}	-2 ~ 16	V	DC RIN=2kohm		
		-16		At reverse battery condition, t<2min, RIN=2kohm, RSEN=2kohm		
IN pin current	I_{IN}	10	mA	DC		
Voltage at IS pin	VIS	VCC	V	DC RIS=1kohm		
		-16	V	At reverse battery condition, t<2min, RL=3.4ohm, RIS=1kohm		
IS Reverse current at reverse battery condition	IIS(Rev)	-30	mA	At reverse battery condition, t<2min, RL=3.4ohm		
Voltage at SEN pin	V_{SEN}	-2 ~ 16	V	DC RSEN=2kohm		
		-16		At reverse battery condition, t<2min RIN=2kohm, RSEN=2kohm		
SEN pin current	I_{SEN}	10	mA	DC		
Channel Temperature	Tch	-40 to +150	degreeC			
Storage Temperature	Tstg	-55 to +150	degreeC			
ESD susceptibility	V_{ESD}	2000	V	HBM	AEC-Q100-002 std. R=1.5kohm, C=100pF	All pin
		4000			IEC61000-4-2 std. R=330ohm, C=150pF, 100nF at VCC and OUT	VCC, OUT
		200	V	MM	AEC-Q100-003 std. R=0ohm, C=200pF	
Inductive load switch-off energy dissipation single pulse	EAS	70	mJ	VCC=13.5V, Tch,start<150degreeC, RL=3.4ohm		
Inductive load switch-off energy dissipation repetitive pulse	EAR	35	mJ	VCC=13.5V, Tch,start=85degreeC, RL=3.4ohm		

Remark) All voltages refer to ground pin of the device

3.4 Thermal Characteristics

Parameter	Symbol	Min	Typ	Max	Unit	Test Condition
Thermal characteristics	Rth(ch-a)		35		degree C/W	According to JEDEC JESD51-2, -5, -7 on FR4 2s2p board
	Rth(ch-c)		1.1		degree C/W	All channel

3.5 Electrical Characteristics

Operation function

Tch=-40 to 150degreeC, Vcc=7 to 18V, unless otherwise specified

Parameter	Symbol	Min	Typ	Max	Unit	Test Condition	
Operating Voltage	V_{CC}	4.5		28	V	V_{IN}=4.5V RL=3.4ohm	
Operating current per channel	I_{GND}		2.2	4	mA	VIN=4.5V	
Output Leakage current per channel	$I_{L(off)}$			0.5	µA	Tch=25°C	VCC=13.5V, VIN=0V, VSEN=0V,
				3		Tch=-40~125°C	VIS=0V, VOUT=0V, VGND=0V
Standby current	$I_{CC(off)}$			0.5	µA	Tch=25°C	VCC=13.5V, VIN=0V, VSEN=0V,
				2		Tch=-40~85°C	VIS=0V, VOUT=0V, VGND=0V
On-state resistance per channel	Ron		20		mohm	Tch=25°C, IL=4.0A	
				48		Tch=150°C, IL=4.0A	
Low level IN pin voltage	V_{IL}			0.8	V		
High level IN pin voltage	V_{IH}	2.5			V		
Low level IN pin current	I_{IL}	2		25	µA	VIN=0.8V	
High level IN pin current	I_{IH}	2		25	µA	VIN=2.5V	
Clamping IN pin voltage [1)]	V_{ZIN}	5	6		V		
Low level SEN pin voltage	V_{SENL}			0.8	V		
High level SEN pin voltage	V_{SENH}	2.5			V		
Low level SEN pin current	I_{SENL}	2		25	µA	VSEN=0.8V	
High level SEN pin current	I_{SENH}	2		25	µA	VSEN=2.5V	
Clamping SEN pin voltage[1)]	V_{ZSEN}	5	6		V		
Under voltage shutdown	$V_{CC(Uv)}$			4.5	V		
Under voltage restart	$V_{CC(Cpr)}$			5.0	V		
Turn on time	ton			200	µs	VCC=13.5V, RL=3.4ohm	
Turn on delay time	td(on)			100	µs		
Turn off time	toff			200	µs		
Turn off delay time	td(off)			150	µs		
Slew rate on	dV/dton			1.5	V/µs		
Slew rate off	-dV/dtoff			1.5	V/µs		
Switching drift[1)]	ton-toff	-50		+50	µs	Vcc = 9 to 18V drift from Vcc=13.5V, Tch=-40 to 150degreeC drift from Tch=25degreeC ton; Vout=Vcc-1.5V after input signal active	
Turn on energy loss [1)]	Eon		0.5	1.0	mJ	VCC=13.5V,Tch=25°C, RL=3.4ohm	
Turn off energy loss [1)]	Eoff		0.5	1.0	mJ		
Driving capability [1)]	Dr(capa)	180			mohm	Tch=25°C, VCC=8~16V	
		210				Tch=105°C, VCC=8~16V	

Remark) All voltages refer to ground pin of the device

1) not subjected production test, guaranteed by design

Protection function

Tch=-40 to 150degreeC, Vcc=7 to 18V, unless otherwise specified

Parameter	Symbol	Min	Typ	Max	Unit	Test Condition	
Over current detection current	IL(SC)	47	75		A	VCC=13.5V, Von=5V, Tch=25°C	
Current limitation under power limitation toggling	IL(CL)		33		A	VCC=13.5V	
Current limitation under absolute thermal toggling	IL(TT)		25		A	VCC=13.5V	
Current limitation trigger threshold during turn-on	Von(CL1)		2.0		V	VCC=13.5V	
Current limitation trigger threshold during on-state	Von(CL2)		0.8		V	VCC=13.5V	
Absolute thermal shutdown temperature	aTth	150			°C		
Thermal hysteresis for absolute thermal toggling	aTth,hys		10		°C		
Power limitation thermal shutdown temperature	dTth		60		°C		
Power limitation restart temperature	dTth,restart		30		°C		
Output clamp at inductive load switch off	Von,clamp	30		40	V	VCC=13.5V, IL=40mA, Tch=25°C	
Output current while GND disconnection	IL(GND)			1	mA	IIN=0A, ISEN=0A, IGND=0A, IIS=0A	
Output voltage drop at reverse battery condition	Vds(rev)			0.9	V	Tch=25°C	VCC=-13.5V, RL=3.4ohm
				0.7		Tch=150°C	

Remark) All voltages refer to ground pin of the device

Diagnosis function

Tch=-40 to 150degreeC, Vcc=7 to 18V, VIN=4.5V, VSEN=4.5V, unless otherwise specified

Parameter	Symbol	Min	Typ	Max	Unit	Test Condition	
Current sense ratio	KILIS	2720	3400	4080		IL=4.8A	
		2380	3400	5400		IL=0.9A	
Current sense drift depend on temperature for single point calibration	dKILIS,cal	-11.4		13.1	%	IL=1.5A	Calibration point: IL=2.4A, VCC=13.5V, Tch=25°C
		-8.2		7.9		IL=2.0A	
		-6.5		6.0		IL=2.4A	
		-4.8		6.6		IL=3A	
		-5.5		7.5		IL=4A	
Sense current offset current	Iis,offset			50	µA	IL=0A, Tch=25degreeC	
Sense current leakage current	Iis,dis			1	µA	VIN=0V, VSEN=0V	
Sense current under fault condition	Iis,fault	3		9.5	mA	VCC=13.5V, RIS=0.67kohm	
		3.5		9		VCC=13.5V, RIS=1kohm	
		3.5		5.5		VCC=13.5V, RIS=2kohm	
Open load detection threshold at off-state	VOUT(OL)	2.0		5.0	V	VIN=0V, Tch=-40~105°C	
OUT terminal current at Open load condition	IOUT(OL)	-1.0			µA	VIN =0V	
Open load detection delay after input negative slope	tdop		300		µs	VIN=4.5V to 0V, VOUT>VOUT(OL)	

Remark) All voltages refer to ground pin of the device

Diagnosis function

Tch=-40 to 150degreeC, Vcc=7 to 18V, VIN=4.5V, VSEN=4.5V, unless otherwise specified

Parameter	Symbol	Min	Typ	Max	Unit	Test Condition
Sense current settling time after input signal positive slope	tsis(on)			250	µs	VCC=13.5V, VIN=0V to 4.5V, IL/IIS=KILIS, RL=3.4ohm
Sense current settling time after input signal negative slope	tsis(off)			10	µs	VIN=4.5V to 0V
Sense current settling time after sense enable during on-state 1)	tssen(on)			20	µs	VSEN=0V to 4.5V, RL=3.4ohm
Sense current settling time after sense disable during on-state 1)	tssen(off)			20	µs	VSEN=4.5V to 0V, RL=3.4ohm
Sense current settling time during on-state 1)	tsis(LC)			20	µs	RL=3.4ohm to 1.7ohm
Fault signal delay after over current detection 1)	tdsc(fault)			10	µs	VIN=0V to 4.5V, IL=IL(SC)
Fault signal delay after power limitation valid 1)	tdpl(fault)			10	µs	Von>Von(CL1)
Fault signal delay after power limitation invalid 1)	tdpl(off)			30	µs	Von<Von(CL1)
Fault signal delay after absolute thermal shutdown 1)	tdot(fault)			10	µs	IIS→IIS,fault
Fault signal delay after open load detection at off-state 1)	tdop(fault)			10	µs	VIN=0V, VOUT>VOUT(OL)
Fault signal delay after input negative slope 1)	tdoff(fault)			10	µs	VIN=4.5V to 0V

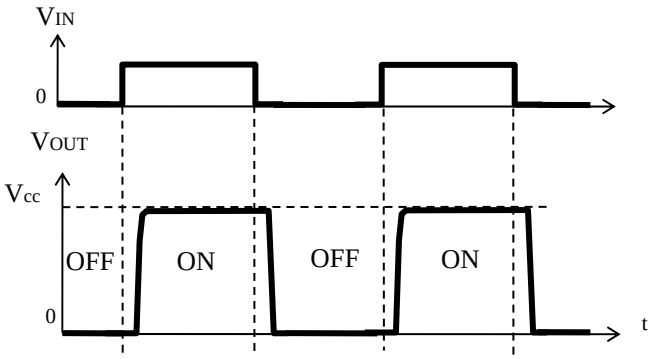
Remark) All voltages refer to ground pin of the device

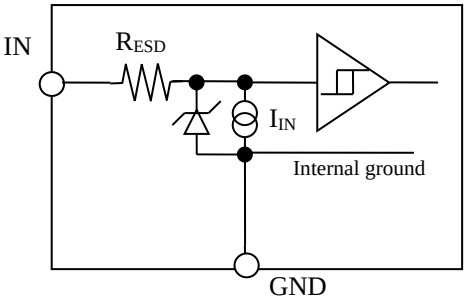
1) not subjected production test, guaranteed by design

3.6 Feature Description

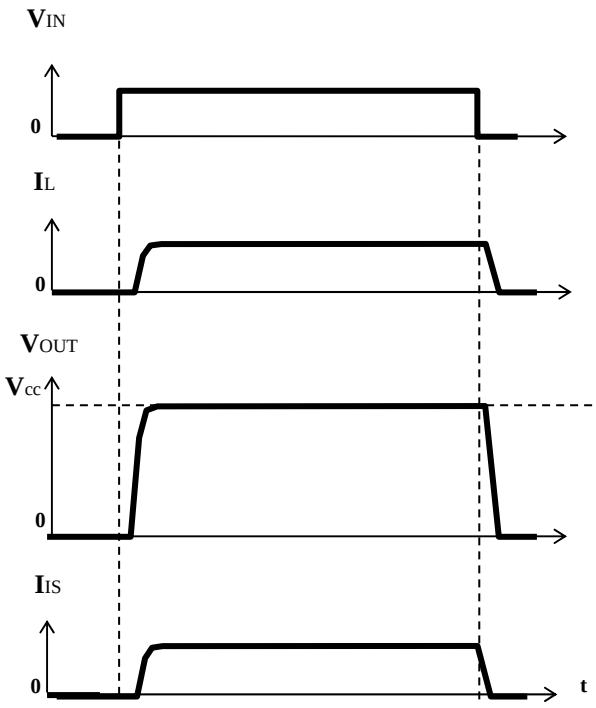
3.6.1 Driving Circuit

The high-side output is turned on, if the input pin is over VIH. The high-side output is turned off, if the input pin is open or the input pin is below VIL. Threshold is designed between VIH min and VIL max with hysteresis. IN terminal is pulled down with constant current source.

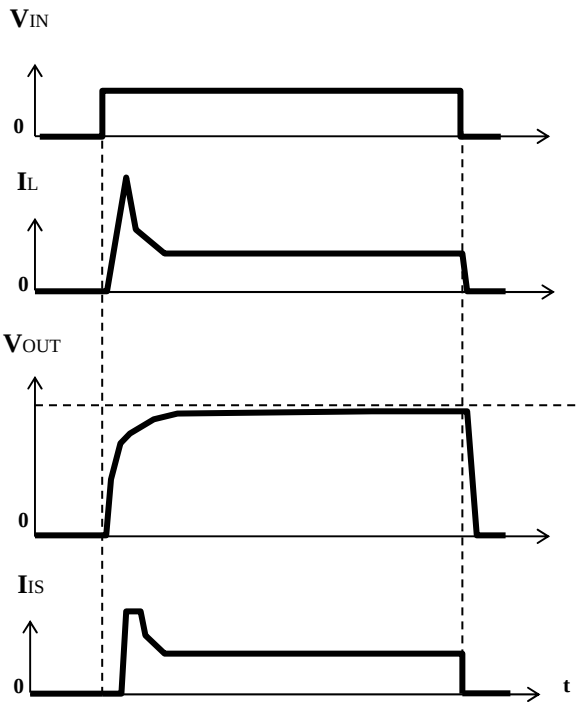




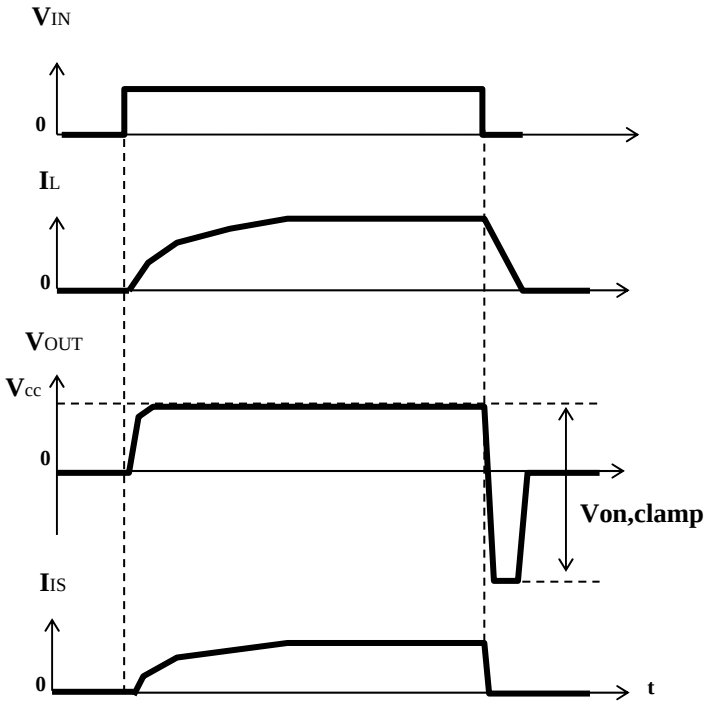
Switching a resistive load



Switching lamps



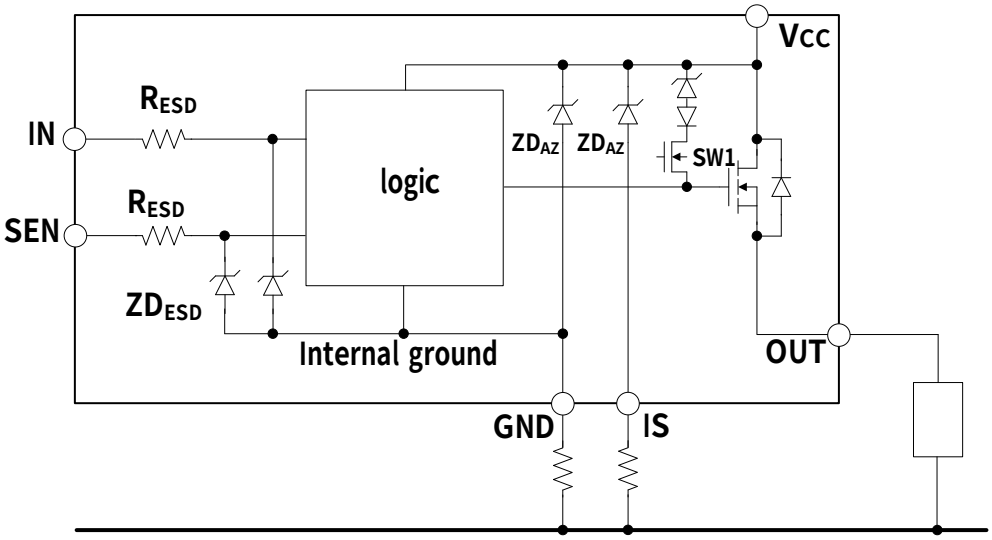
Switching an inductive load



The dynamic clamp circuit works only when the inductive load is switched off. When the inductive load is switched off, the voltage of OUT falls below 0V. The gate voltage of SW1 is then nearly equal to GND. Next, the voltage at the source of SW1 (= gate of output MOS) falls below the GND voltage.

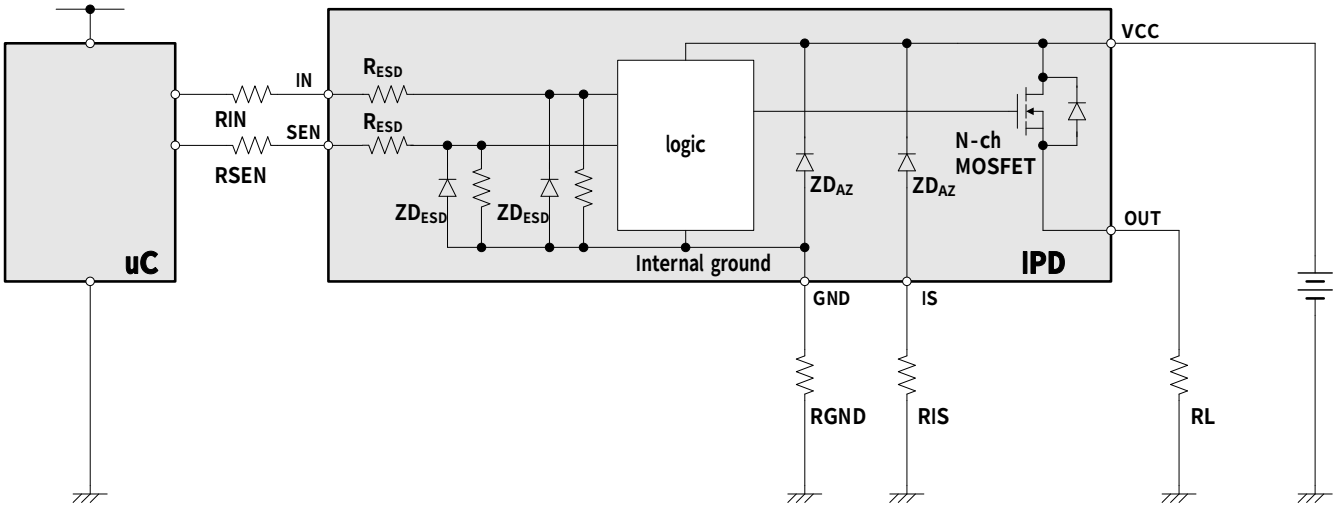
SW1 is turned on, and the clamp diode is connected to the gate of the output MOS, activating the dynamic clamp circuit.

When the over-voltage is applied to VCC, the gate voltage and source voltage of SW1 are both nearly equal to GND. SW1 is not turned on, the clamp diode is not connected to the gate of the output MOS, and the dynamic clamp circuit is not activated.



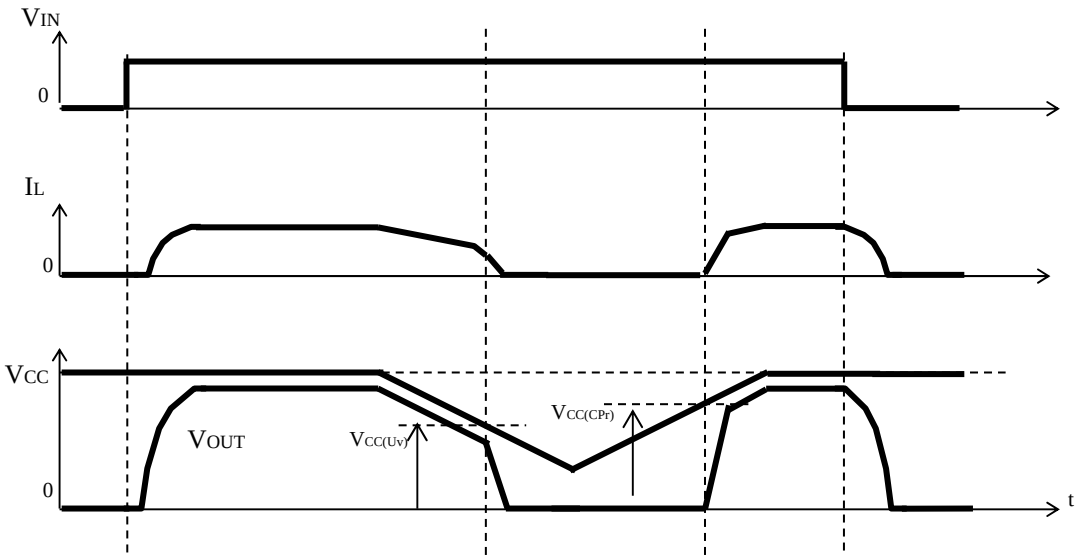
3.6.2 Device behavior at over voltage condition

In case of supply voltage greater than Vload dump, logic part is clamped by ZD_{AZ} (35V min). And current through of logic part is limited by external ground resistor. In addition, the power transistor switches off in order to protect the load from over voltage. Permanent supply voltage than V_{load} dump must not be applied to VCC.



3.6.3 Device behavior at low voltage condition

If the voltage supply (V_{CC}) goes down under V_{CC}(Uv), the device outputs shuts down. If voltage supply (V_{CC}) increase over V_{CC}(Cpr), the device outputs turns back on automatically. The device keeps off state after under voltage shutdown. The IS output is cleared during off-state.



3.6.4 Loss of Ground protection

In case of complete loss of the device ground connection, but connected load ground, the device securely changes to off if VIN was initially greater than VIH state or keeps off state if VIN was initially lower than VIL state.

In case of device loss of ground, IN and SEN terminal will/ could/ might be at VCC voltage.

3.6.5 Short circuit protection

Turn-on in an over load condition including short circuit condition

The device shuts down automatically when condition (a) is detected. The sense pin output Iis,fault. Shutdown is latched until the next reset via input pin. The device shuts down automatically when condition (b) is detected. The device restarts automatically in power limitation mode. The device shuts down automatically when condition (c) is detected and restarts automatically in absolute thermal toggling mode. The sense pin output Iis,fault during power limitation mode or thermal toggling mode.

(a) IL > IL(SC)

(b) deltaTch > dTth

(c) Tch > aTth

Over load condition including short circuit condition during on-state

The device runs automatically into power limitation mode when condition (a) is detected once after Von < Von(CL2). The device shuts down automatically when condition (b) is detected. The device restarts automatically in power limitation mode. The device shuts down automatically when condition (c) is detected and restarts automatically in absolute thermal toggling mode. The sense pin output Iis,fault during power limitation mode or thermal toggling mode.

(a) Von > Von(CL2)

(b) deltaTch > dTth

(c) Tch > aTth

Power limitation control

Current limitation control with IL(CL) when auto restart from deltaTch protection.

During the current limitation operation and Von>Von(CL1), the sense pin outputs Iis,fault. Even auto restart from delta Tch protection, if Von<Von(CL1) depends on short circuit impedance condition, the device does not operate as current limitation with IL(CL). In this case, the sense pin output sense current at on-state, Iis,fault at off-state during toggling operation with power limitation mode.

Absolute thermal toggling

Current limitation control with IL(TT) when auto restart from absolute Tch protection.

During the current limitation operation and Von>Von(CL1), the sense pin outputs Iis,fault. Even auto restart from absolute Tch protection, if Von<Von(CL1) depends on short circuit impedance condition, the device does not operate as current limitation with IL(TT). In this case, the sense pin output sense current at on-state, Iis,fault at off-state during toggling operation with thermal toggling mode.

delta Tch

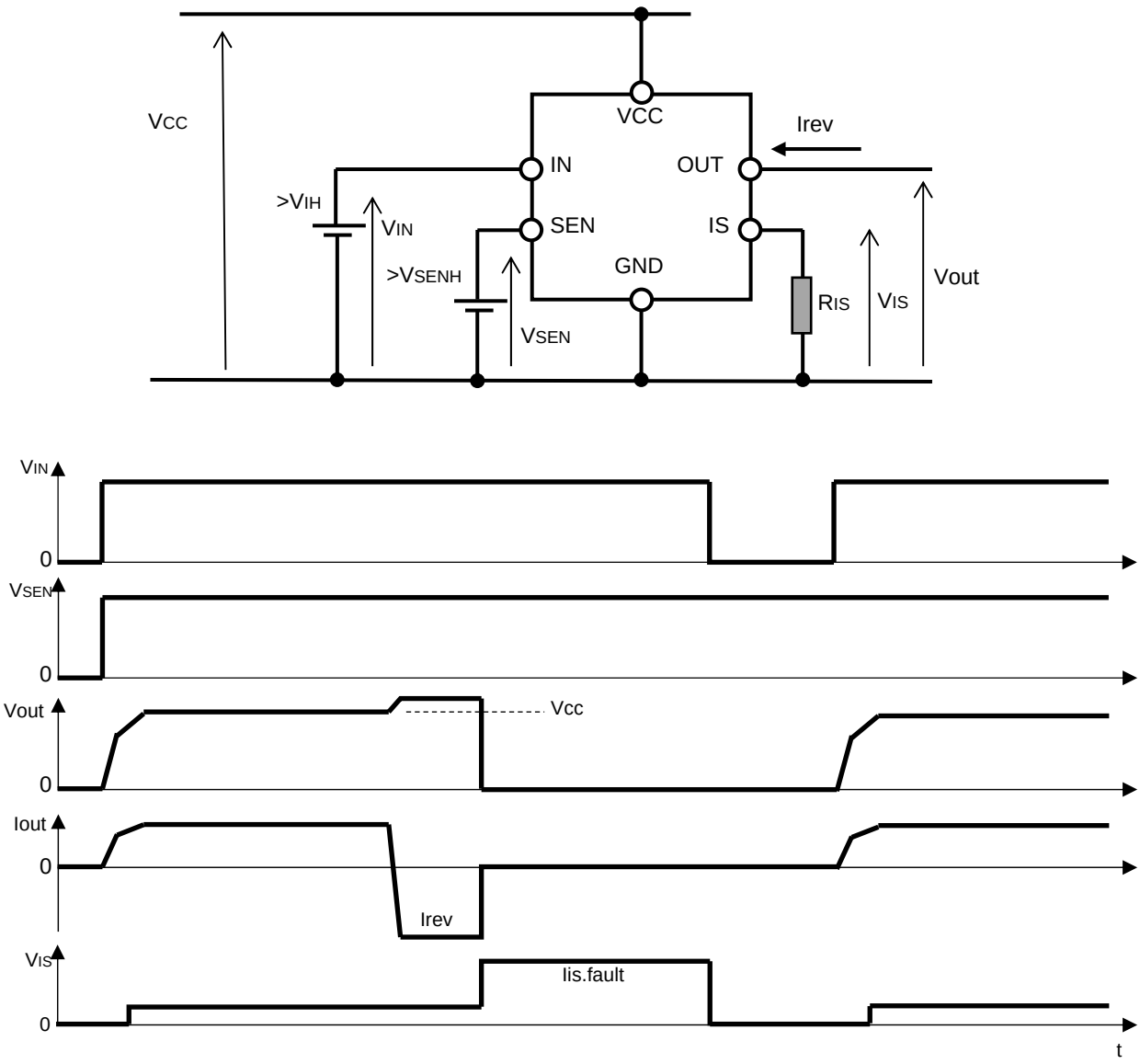
Junction temperature differences between thermal sensor of power area and thermal sensor of control area.

3.6.6 Device behavior at reverse current conduction during on-state

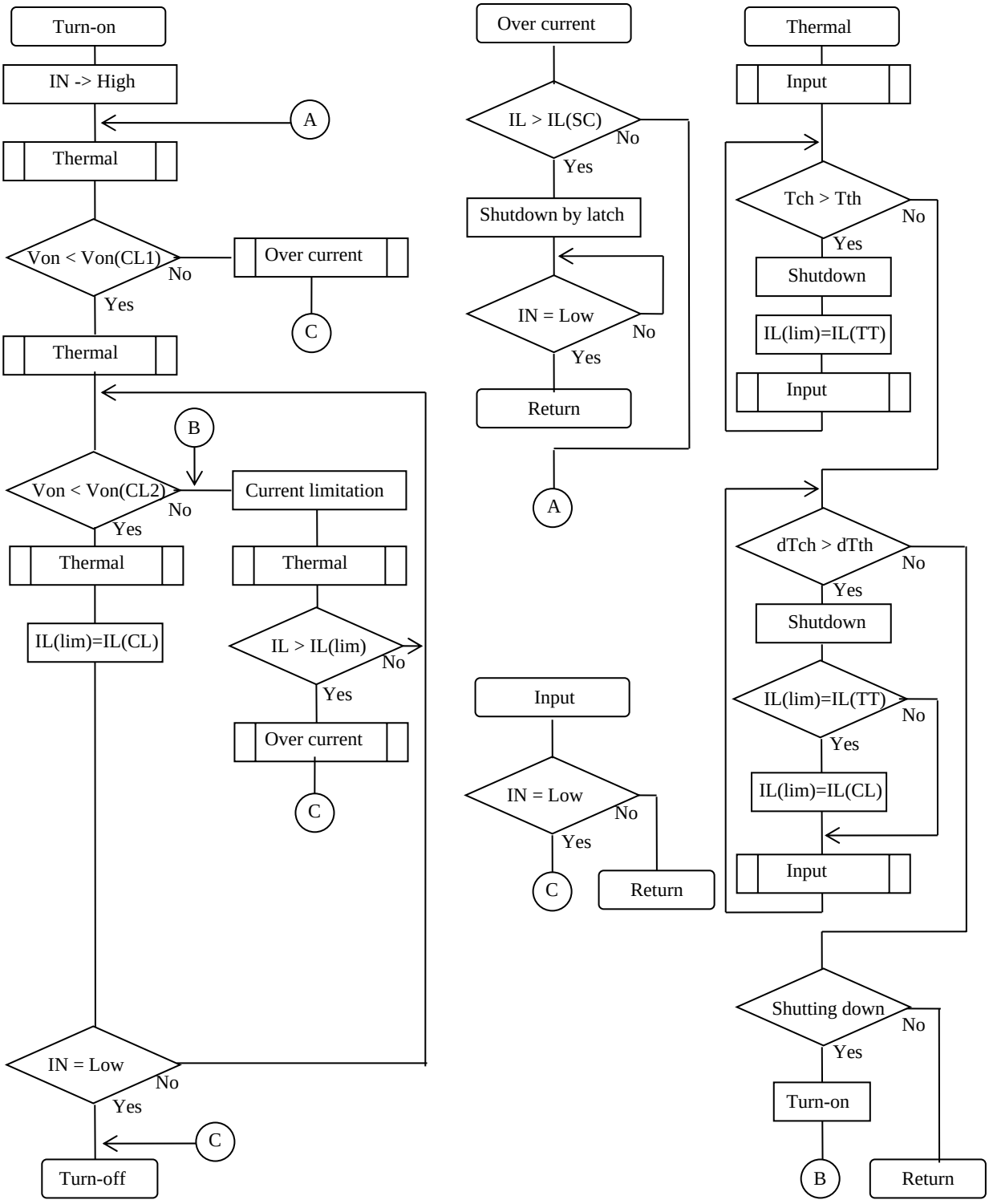
During on-state(VIN>VIH) the device might shut down automatically when Vout>Vcc+0.3V is detected.

And the sense pin outputs Iis,fault if the device shuts down.

If restart is required, please reset via input pin when detect the Iis.fault.



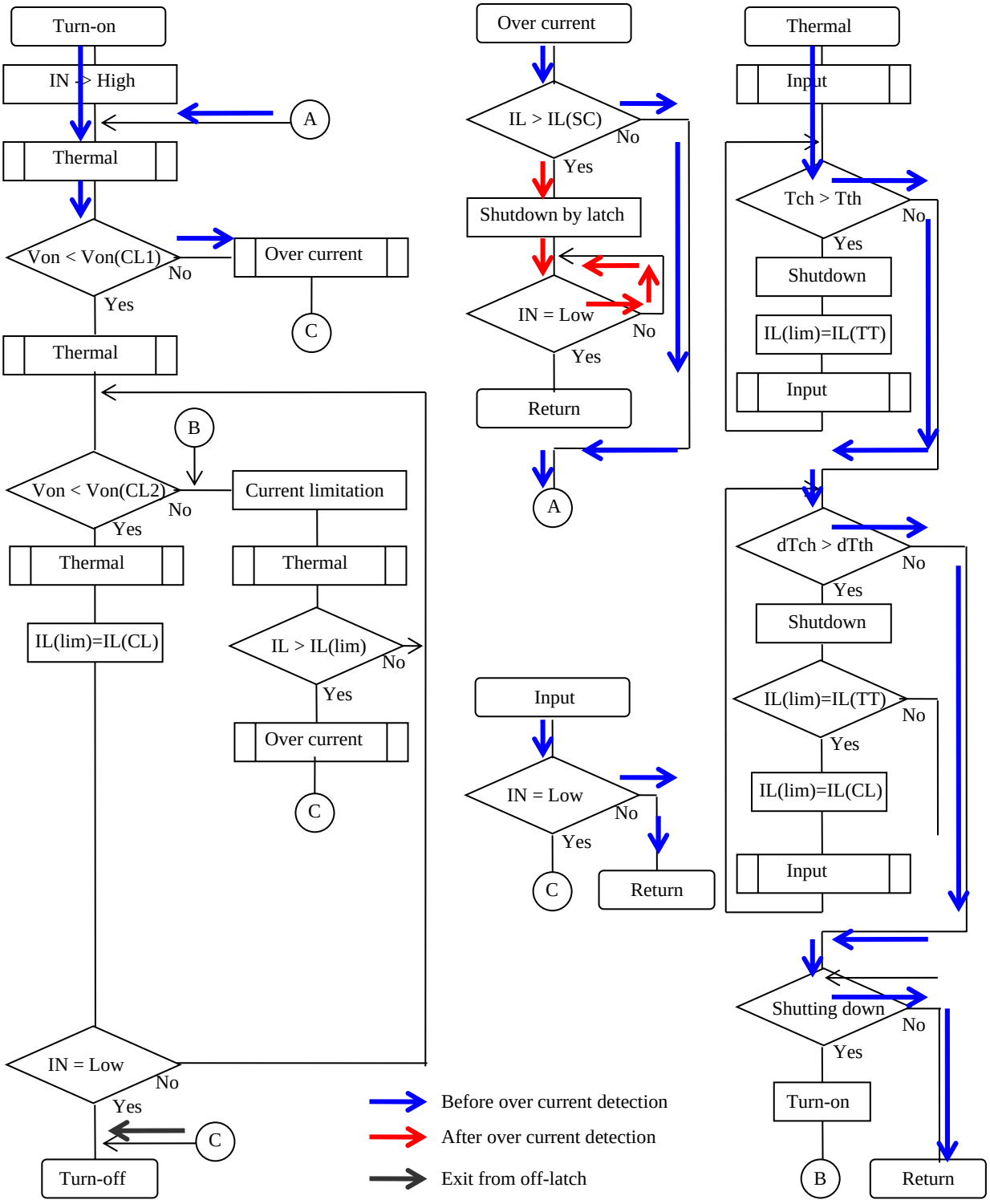
State transition diagram



IL(lim) initial value is power MOSFET saturation current.

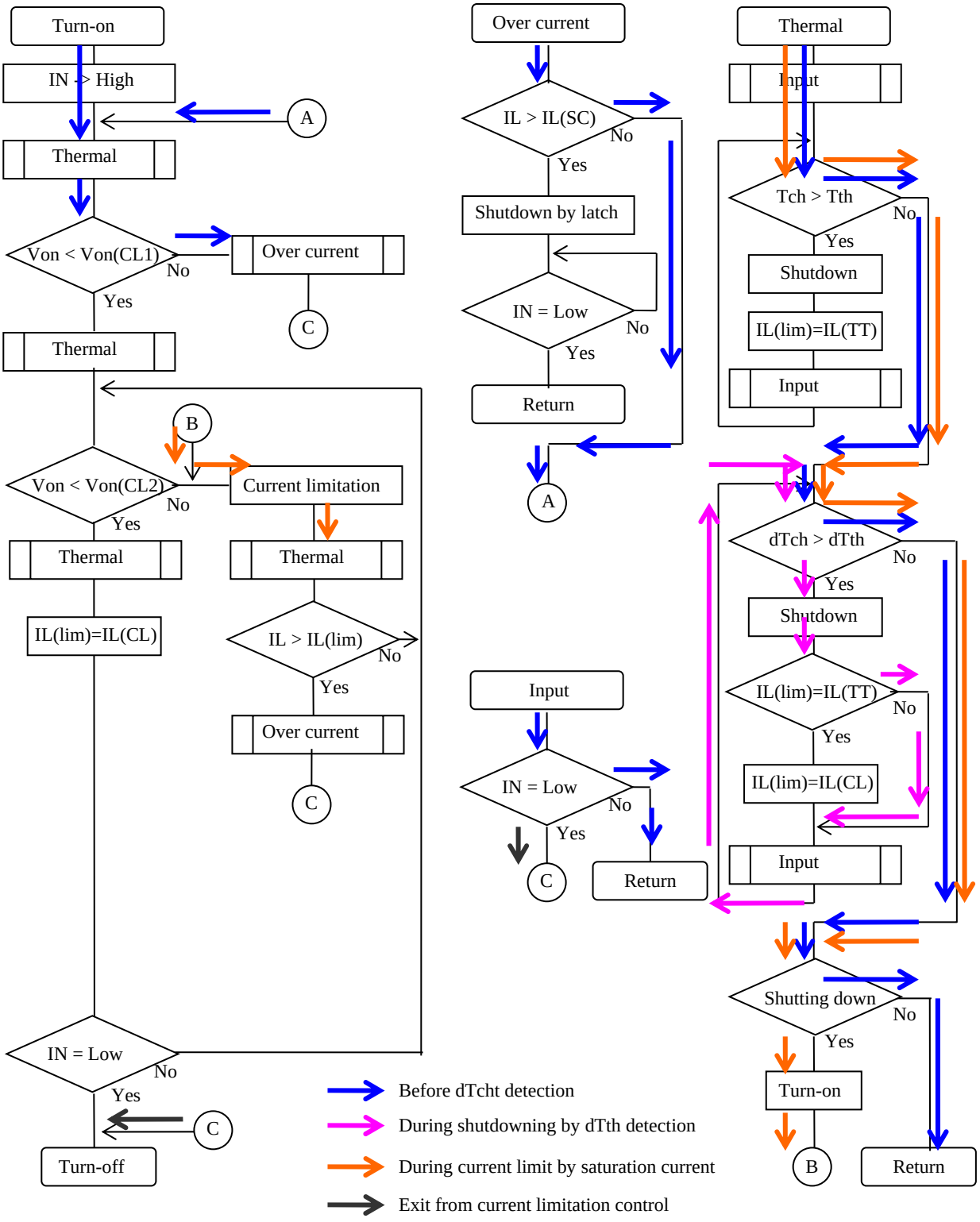
Turn-on in an over load condition including short circuit condition

(a) IL > IL(SC)



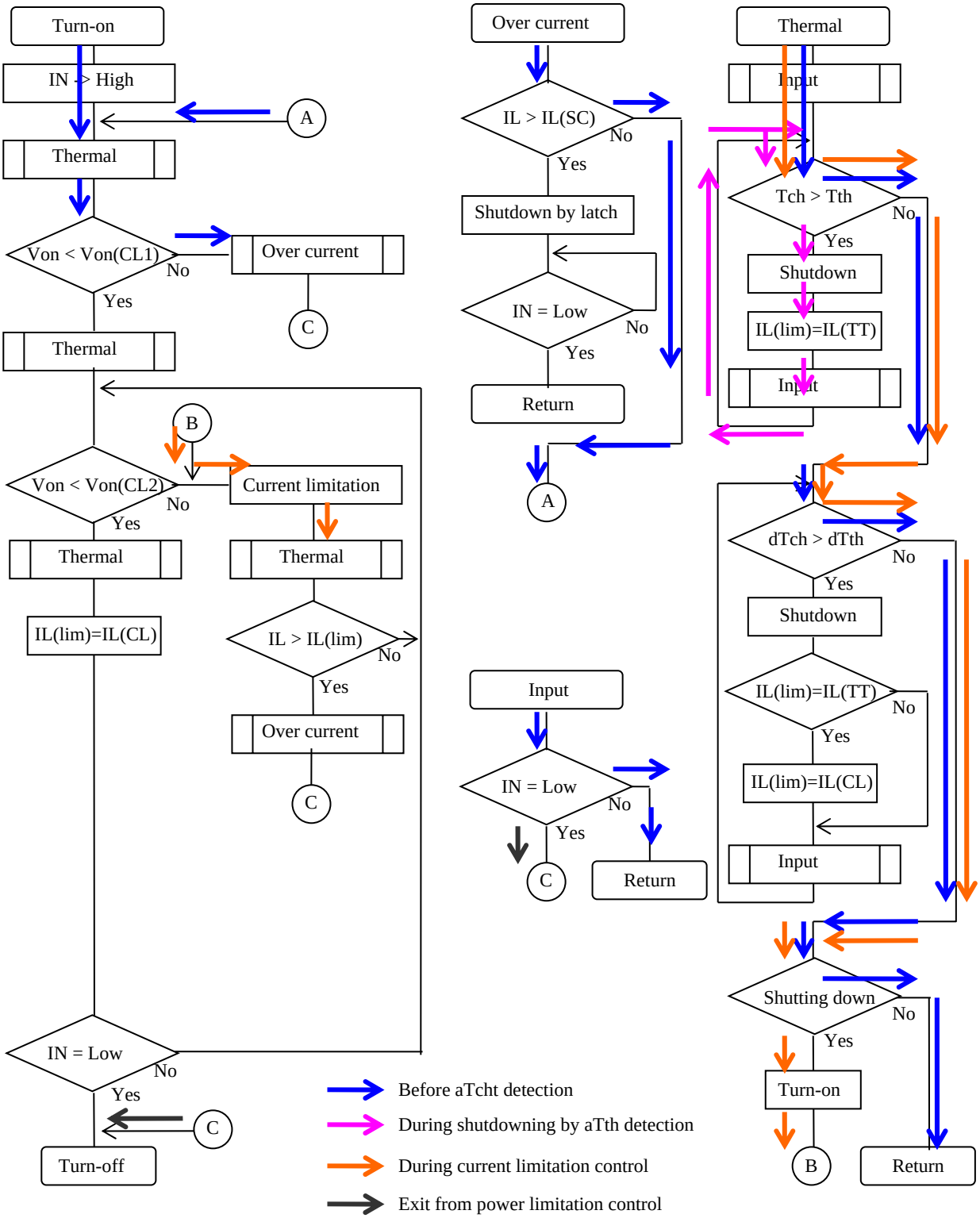
Turn-on in an over load condition including short circuit condition

(b) deltaTch > dTth



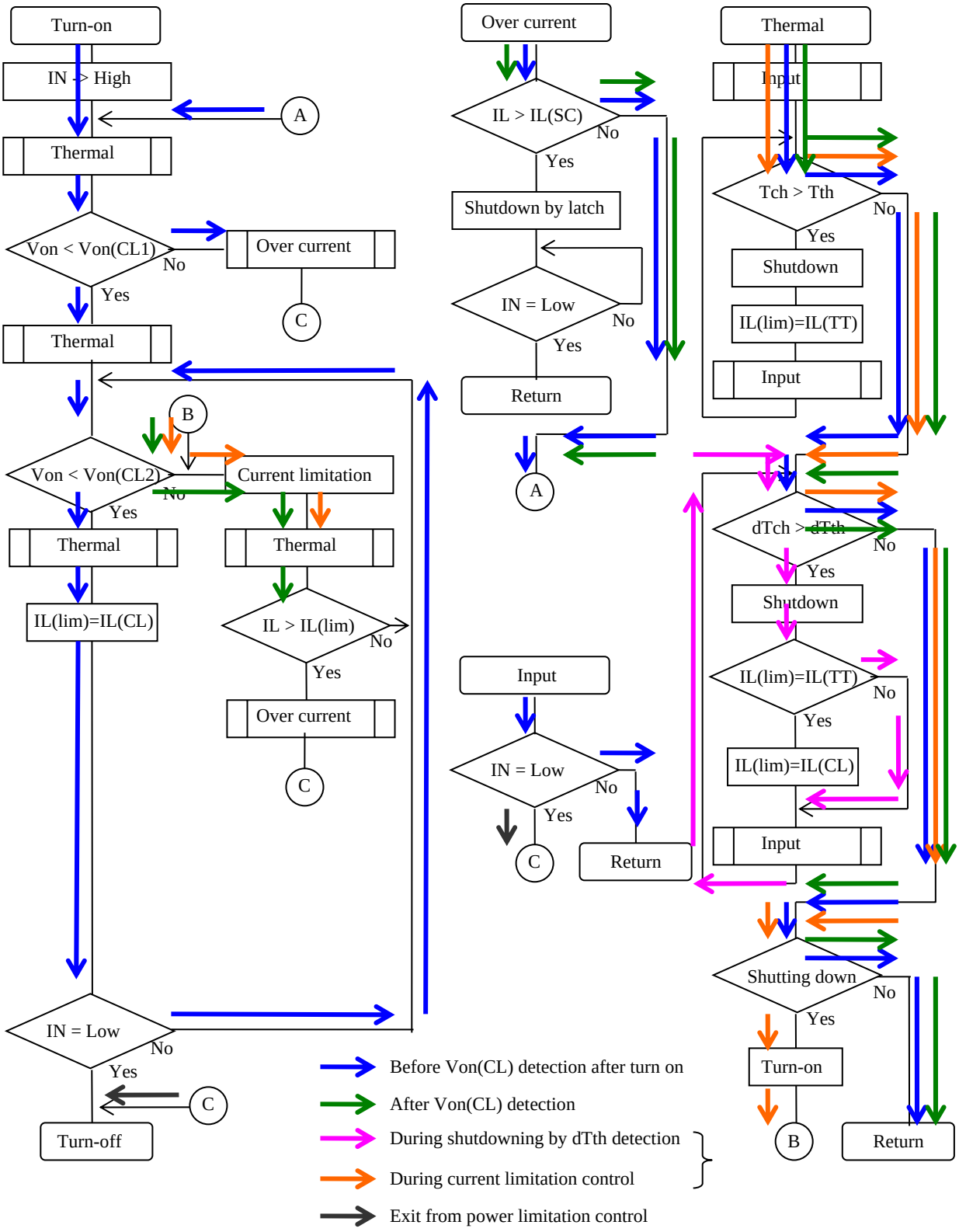
Turn-on in an over load condition including short circuit condition

(c) Tch > aTth



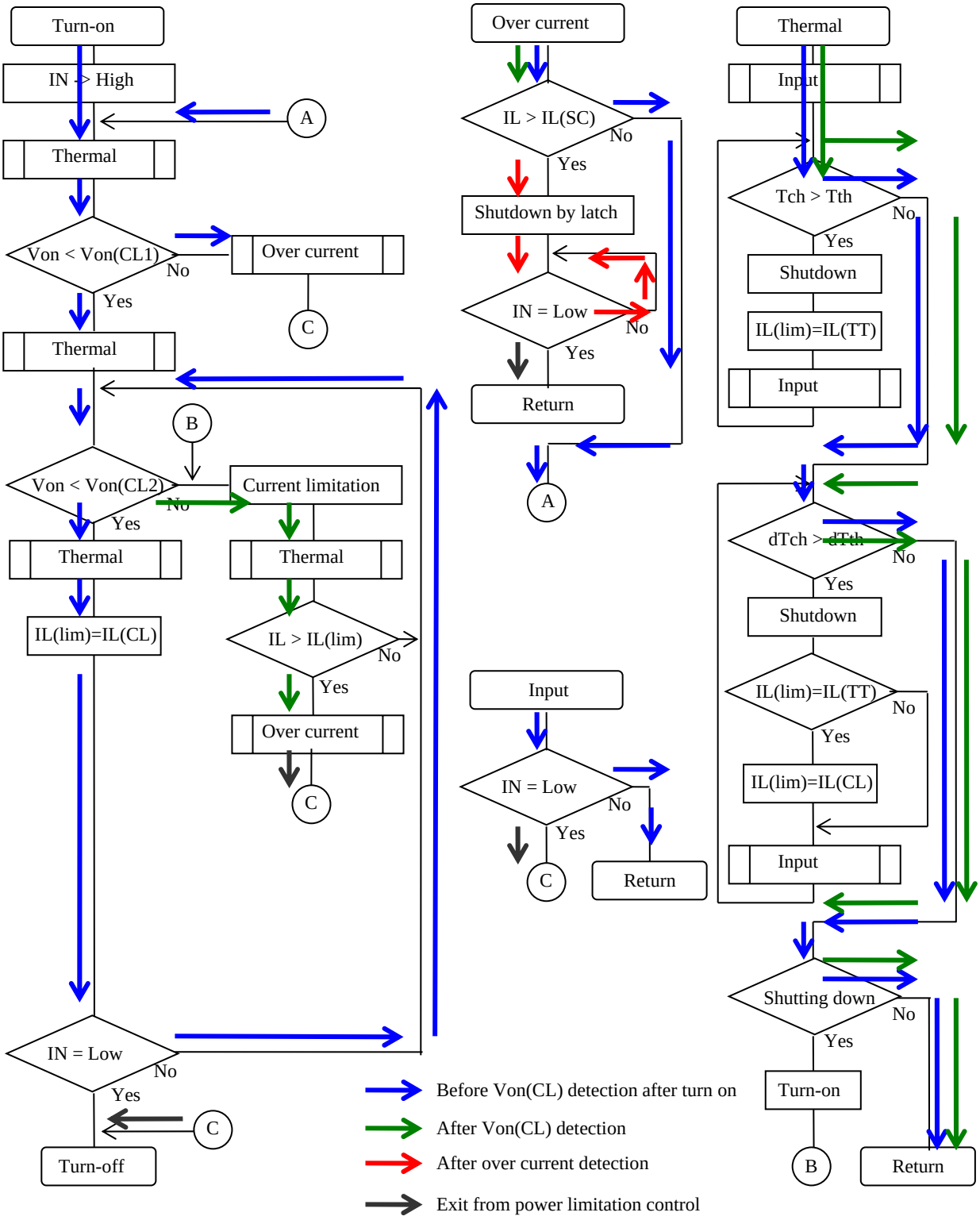
An over load condition which is include a short circuit condition during on-state

(a) Von > Von(CL) with weak short condition



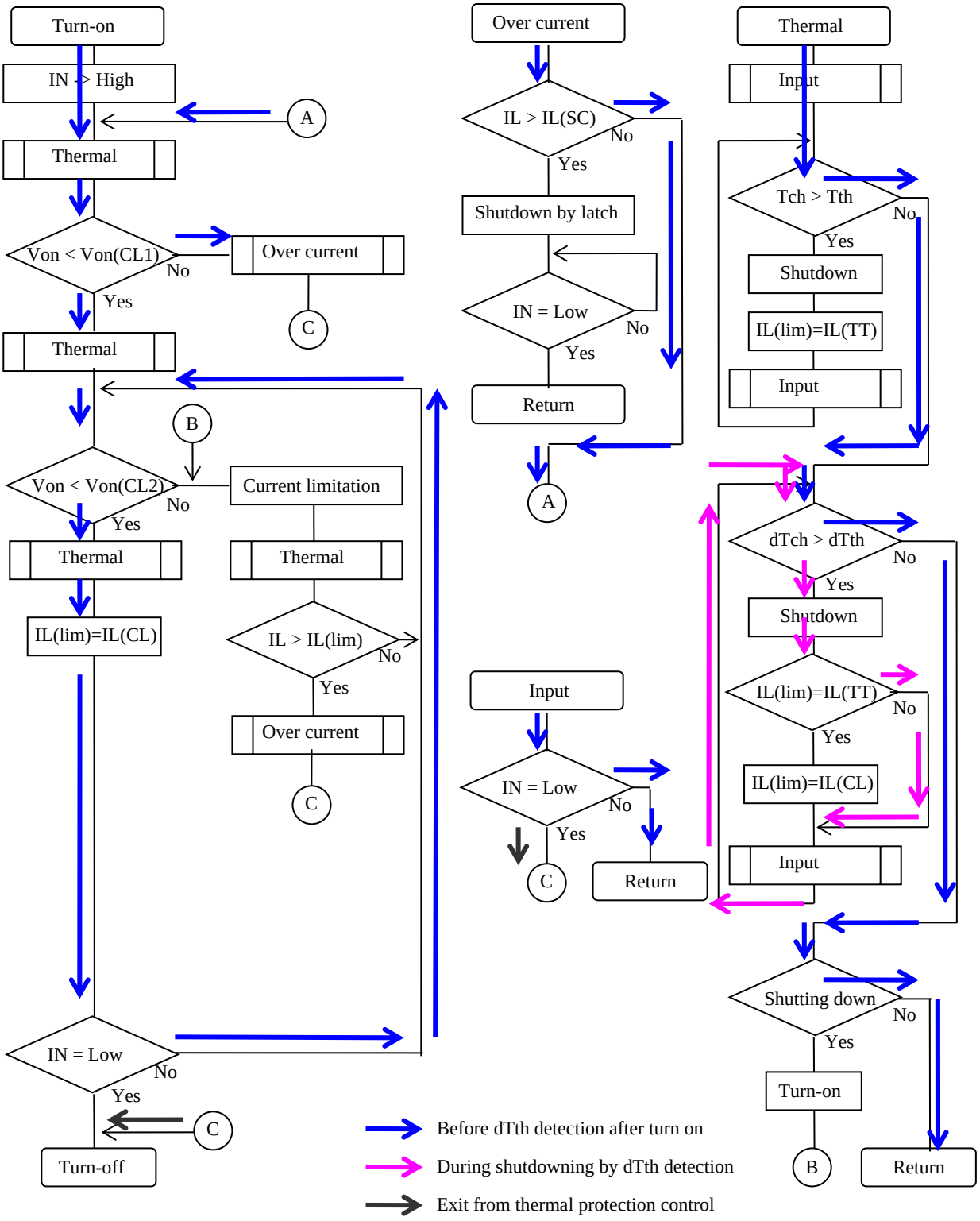
An over load condition including short circuit condition during on-state

(a) Von > Von(CL) with dead condition



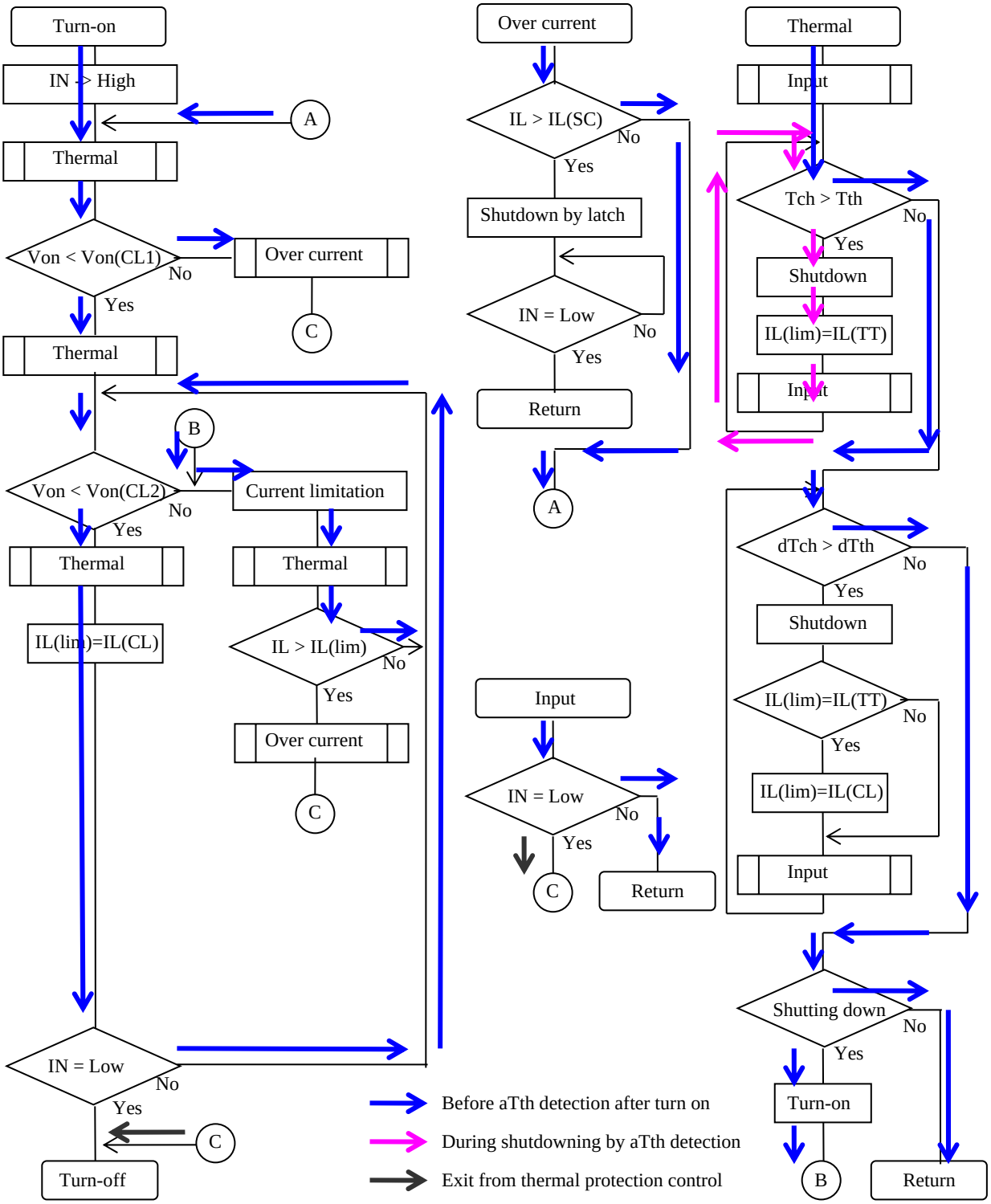
An over load condition including short circuit condition during on-state

(b) deltaTch > dTth



An over load condition including short circuit condition during on-state

(c) Tch > aTth



3.6.7 Diagnostic signal

Truth table

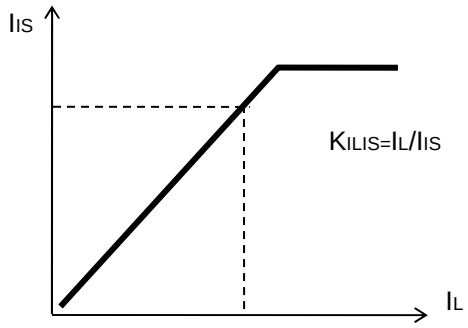
	SEN	Input	Output	Diagnostic output [2]
Normal Operation	H	H	VCC	IIS = IL/KILIS
		L	L [1]	< 1uA (Iis,dis)
Shutdown by over current detection		H	L [1]	Iis,fault [3]
		L	L [1]	< 1uA (Iis,dis)
Power limitation		H	VOUT [6]	IIS = IL/KILIS in case of Von<Von(CL1)
				Iis,fault [4] in case of Von>Von(CL1)
			L [1]	Iis,fault [4]
		L	L [1]	< 1uA (Iis,dis)
Thermal toggling		H	VOUT [6]	IIS = IL/KILIS in case of Von<Von(CL1)
				Iis,fault [5] in case of Von>Von(CL1)
			L [1]	Iis, fault [5]
		L	L [1]	< 1uA (Iis,dis)
Short circuit to VCC		H	VCC	< 2uA (Iis,offset)
		L	VOUT [7]	Iis,fault in case of VOUT>VOUT(OL)
Open Load		H	VCC	< 2uA (Iis,offset)
		L	VOUT [7]	Iis,fault in case of VOUT>VOUT(OL)
X [8]	L	X [8]	X [8]	< 1uA (Iis,dis)

1) In case of OUT terminal is connected to GND via load.
2) In case of IS terminal is connected to GND via resister.
3) IS terminal keeps Iis,fault as long as input signal activate after the over current detection.
4) IS terminal keeps Iis,fault during power limitation if Von>Von(CL1).
5) IS terminal keeps Iis,fault during thermal toggling if Von>Von(CL1)..
6) VOUT depends on the short circuit condition
7) VOUT depends on the ratio of VCC-OUT-GND resistive component.
8) Don’t care

Note: IS terminal output Iis,fault if Von>Von(CL1) within certain time (500us typ.) after turn on.

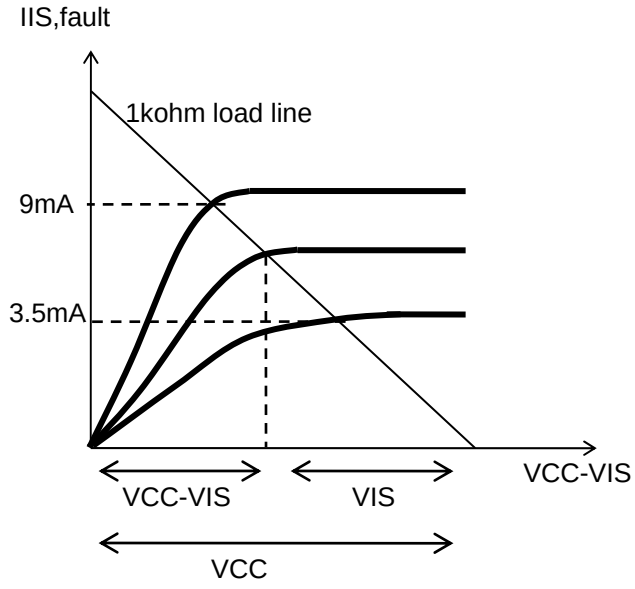
Current sense output

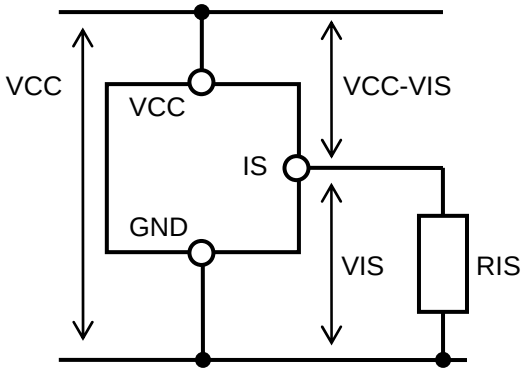
The device output analog feedback current proportional to output current from IS pin. In the case of much higher current than nominal load current, current sense output is saturated.



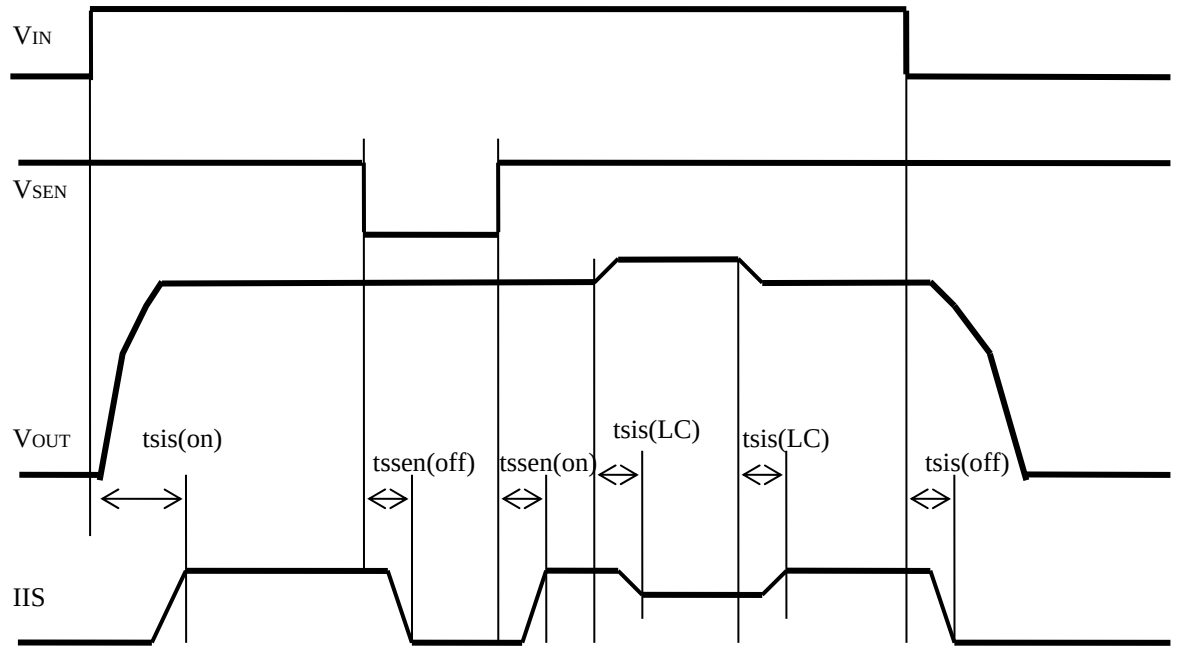
Sense current under fault condition

The device output IIS,fault, constant current, from IS pin under fault condition such as after over current detection, during power limitation and during thermal toggling. IIS,fault is specified with RIS=1kohm condition. IIS,fault is attenuated depends on VCC-VIS voltage. Operation point as IIS,fault output is also depends on RIS condition. For example, In the case of RIS=1kohm, IIS,fault could be 3.5mA to 9mA, VCC-VIS could be 4.5V to 10V, VIS could be 9V to 3.5V if VCC=13.5V. In the case of RIS is higher than 1kohm, Operation point as IIS,fault is lower than specified value but VIS should be higher than RIS=1kohm condition.

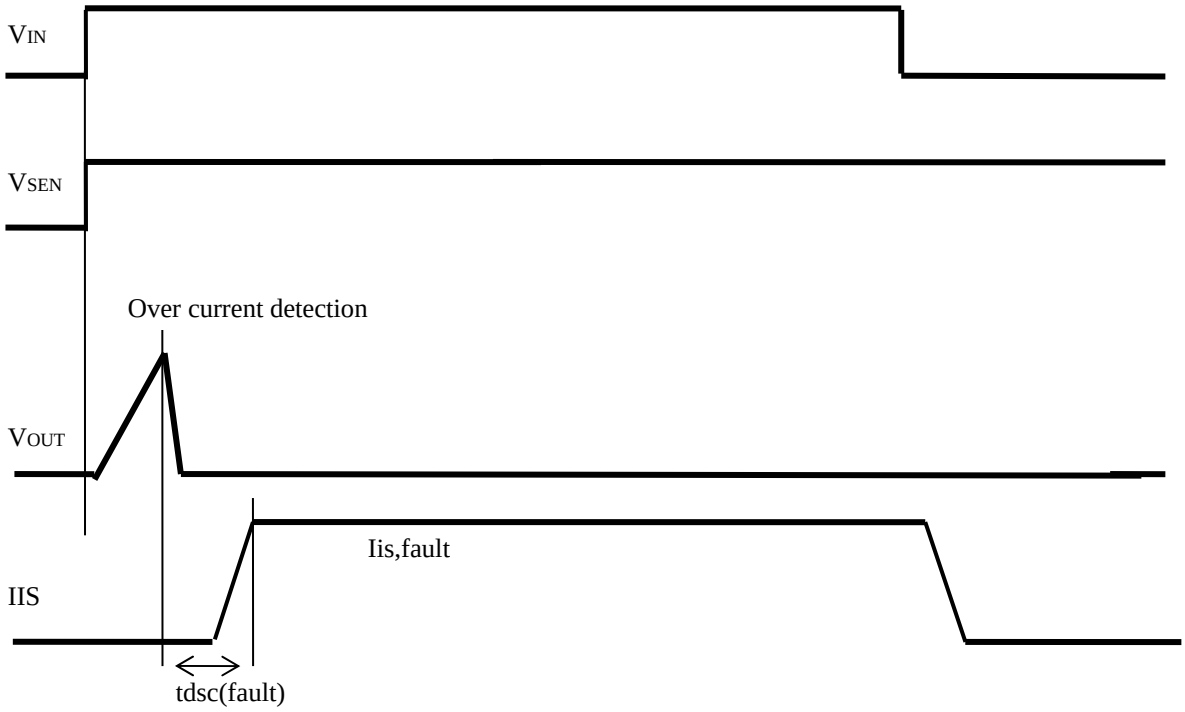




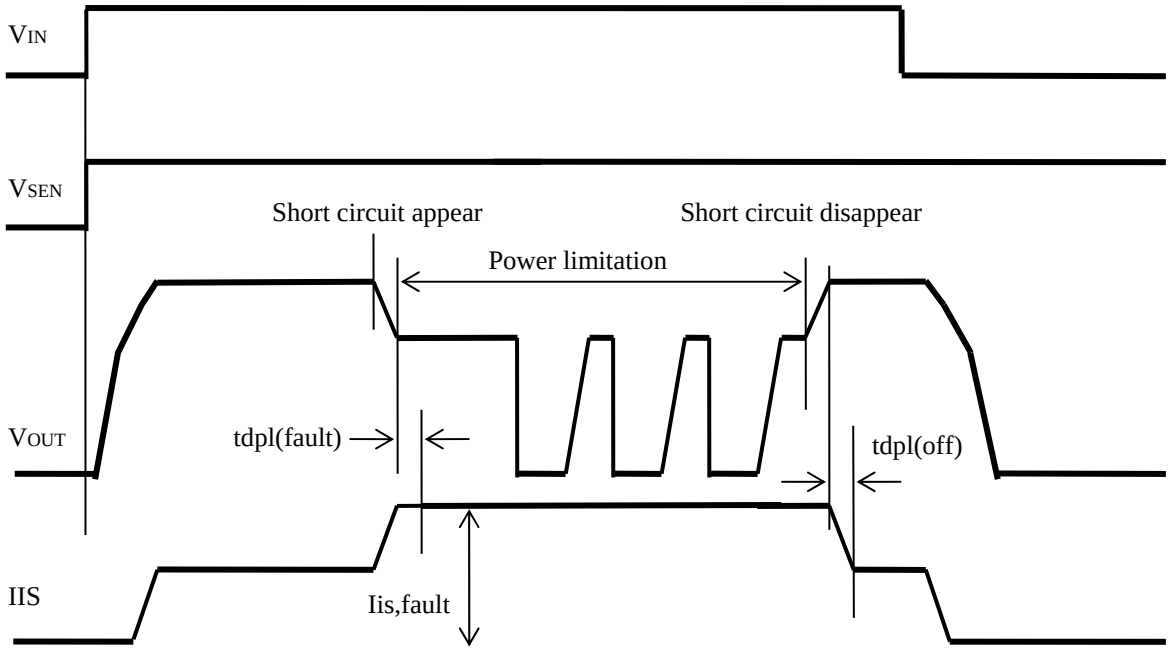
Sense current settling time



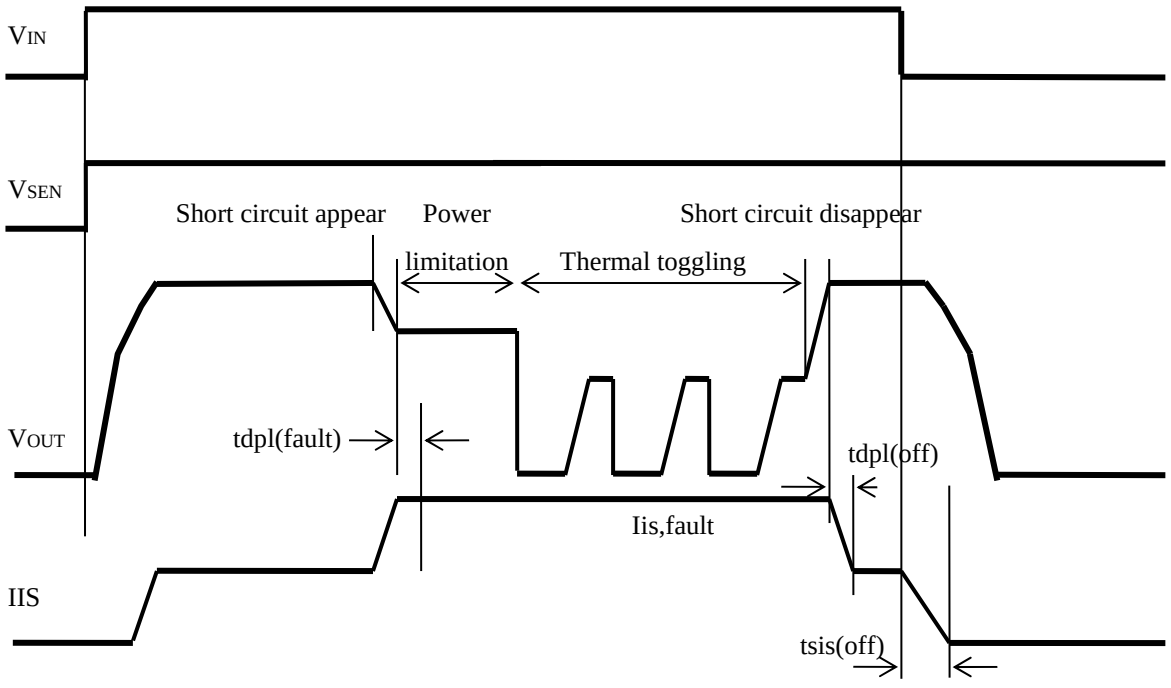
Fault signal delay time at over current detection



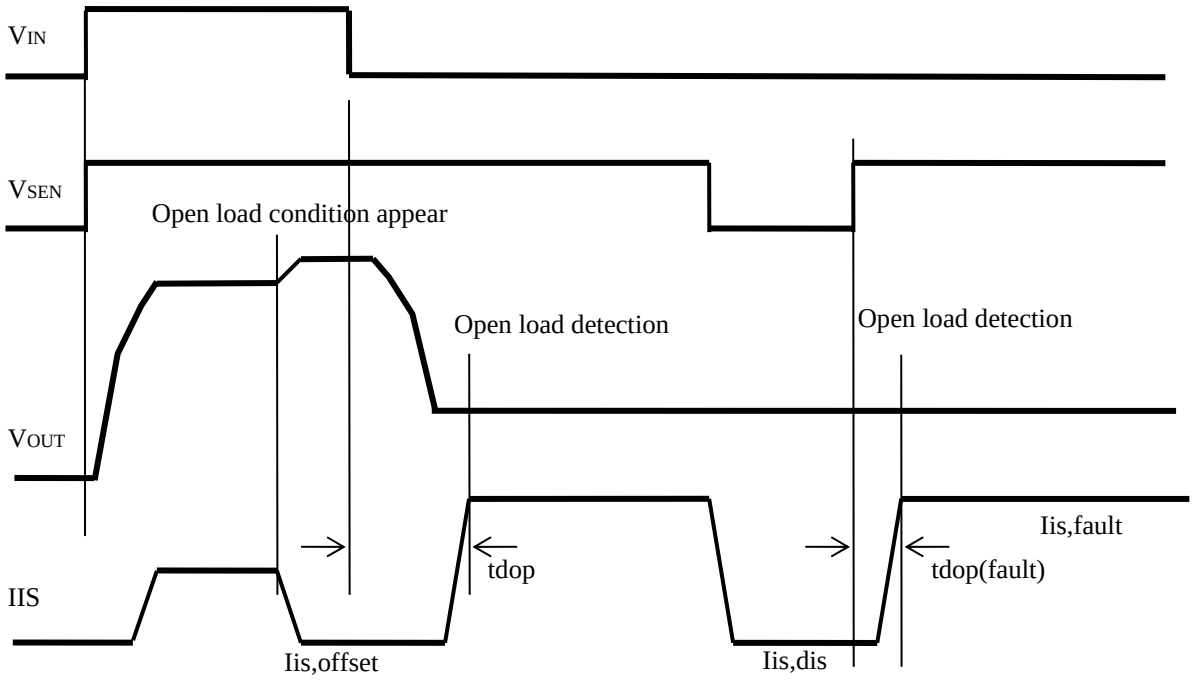
Fault signal delay time at power limitation



Fault signal delay time at Thermal toggling



Fault signal delay time at open load detection

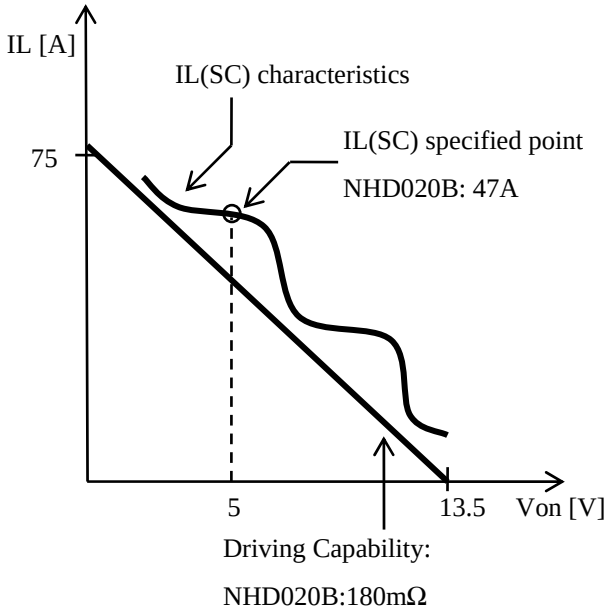


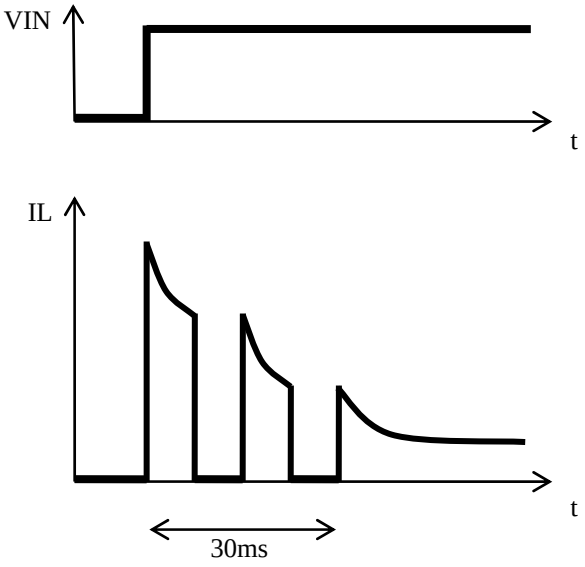
3.6.8 Nominal load

Product	Nominal load
NHD020B	3.4ohm

3.6.9 Driving Capability

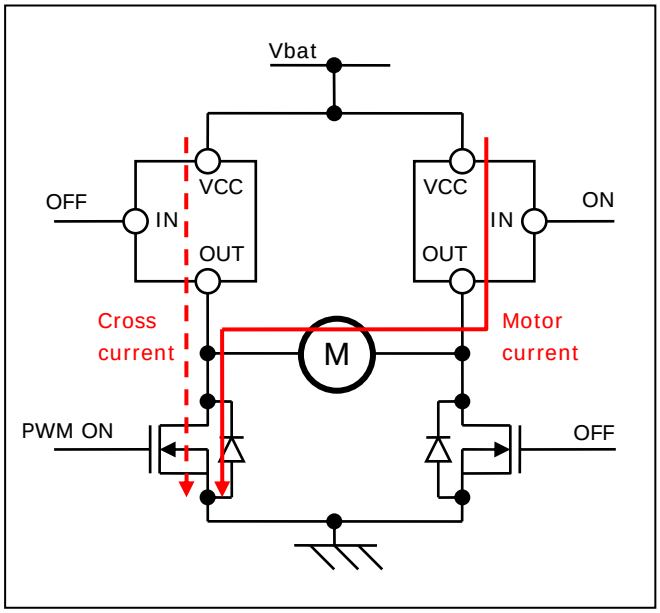
Driving Capability is specified as load impedance including on state resistance in case of this product. Over current detection characteristics is designed below Driving Capability characteristics. If estimated load impedance which comes from peak inrush current is higher than Driving Capability characteristics, this means, the device does not detect inrush current as over current and does not shutdown the output. Depend on the conditions, Power Limitation function may work during inrush current. If estimated load impedance which comes from peak inrush current is higher than Driving Capability characteristics, Power limitation disappear within 30ms. This parameter does not mean that the device can drive the resistive load up to Driving Capability characteristics.





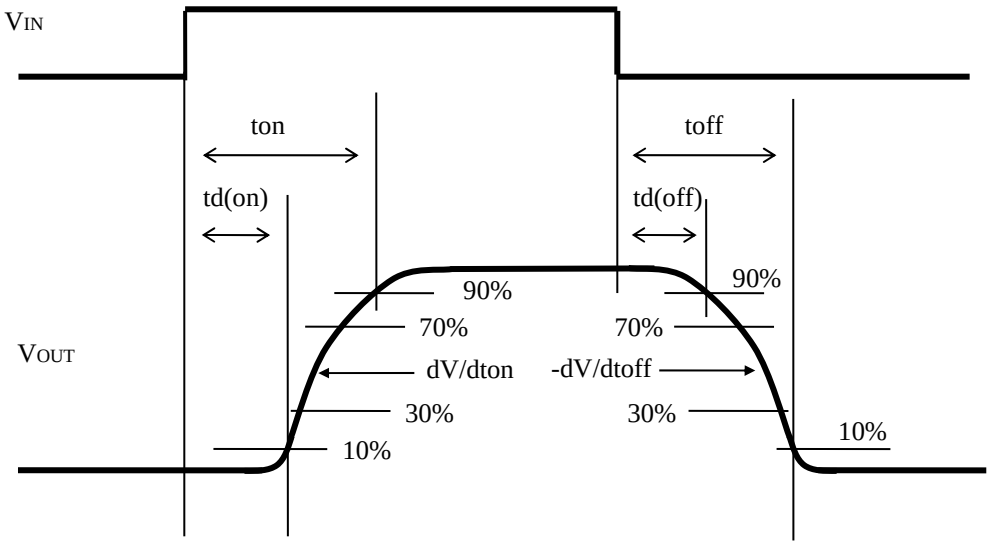
3.6.10 Cross current protection in case of H-bridge high side usage

In case of using High side driver in H-bridge circuit, High side driver protects High side driver itself and also low side driver from high power dissipation by cross current when low side driver switching on.



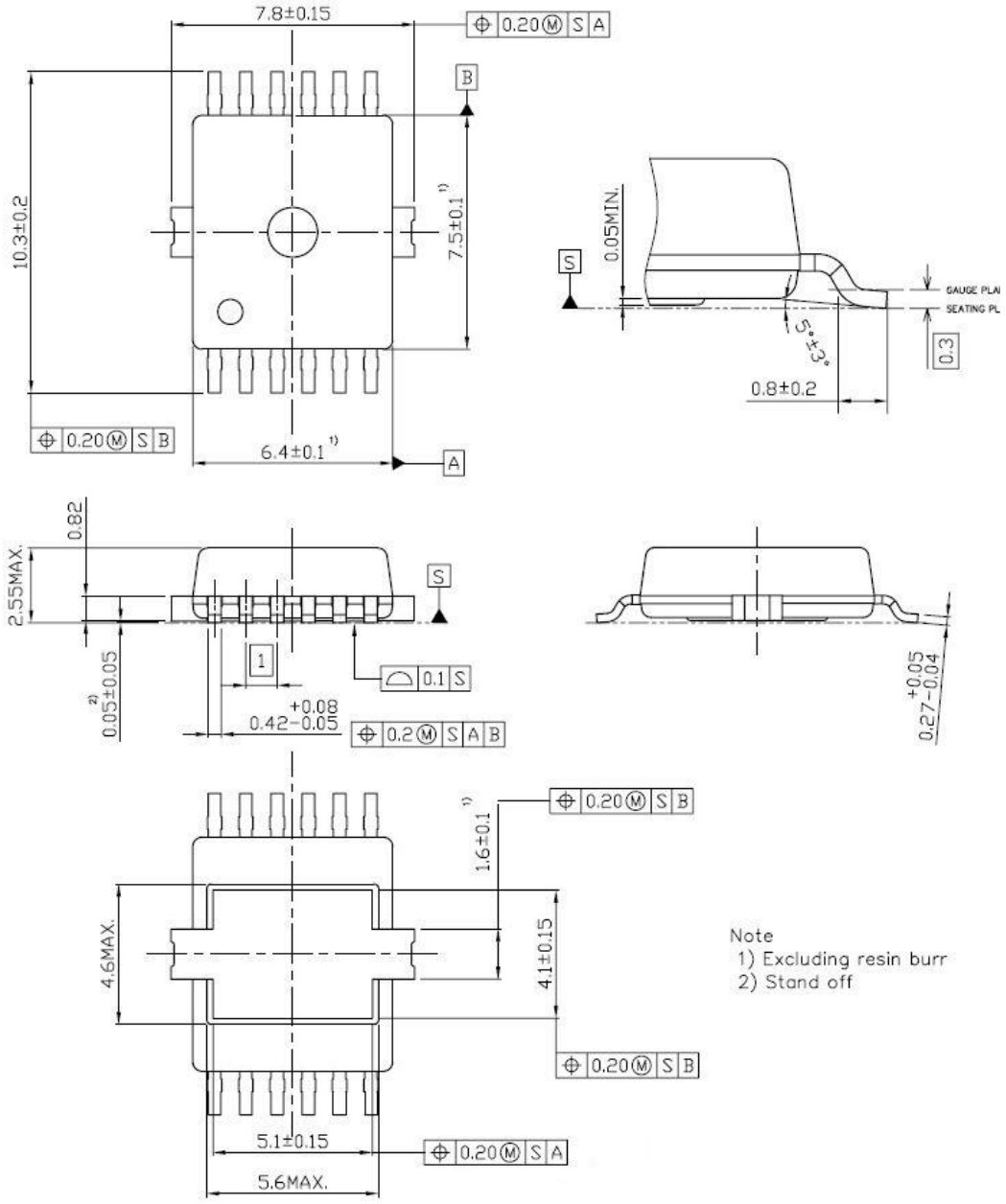
3.6.11 Measurement condition

Switching waveform of OUT terminal



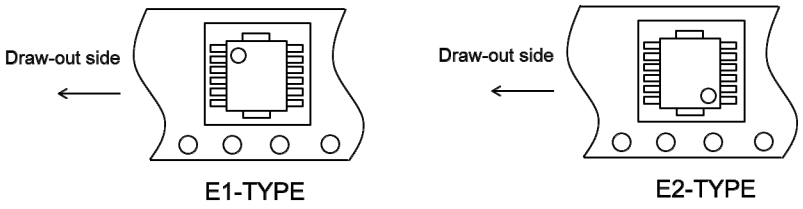
3.7 Package drawing

12-pin Power HSSOP



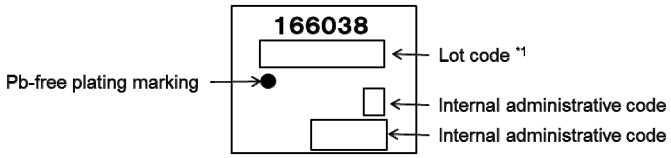
3.8 Taping information

uPD166038T1J

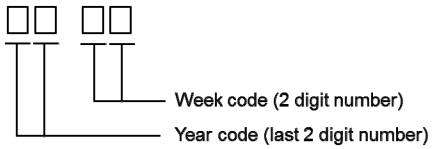


3.9 Marking information

uPD166038T1J

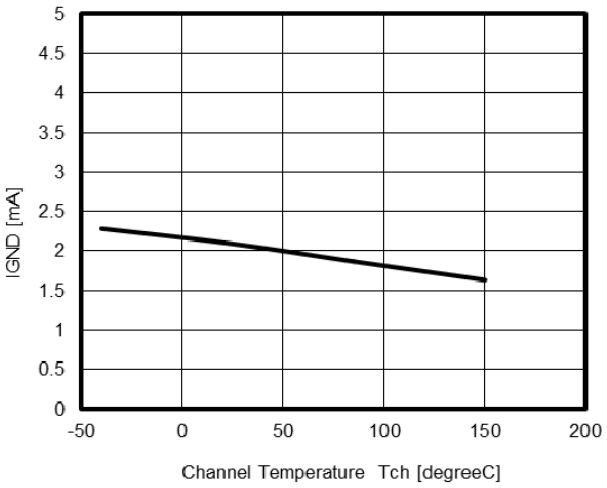


Note: *1. Composition of the lot code

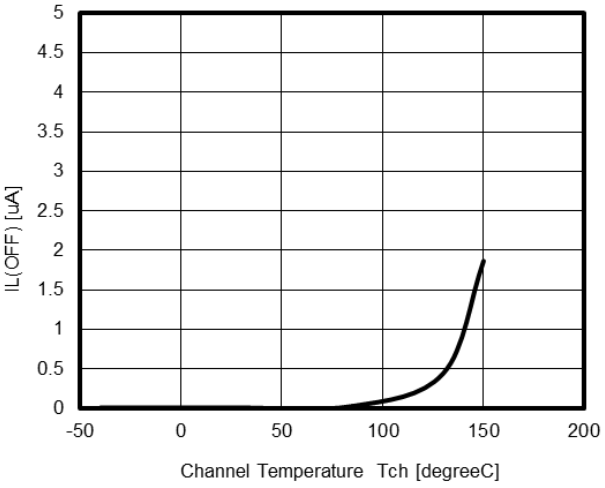


4. Typical characteristics

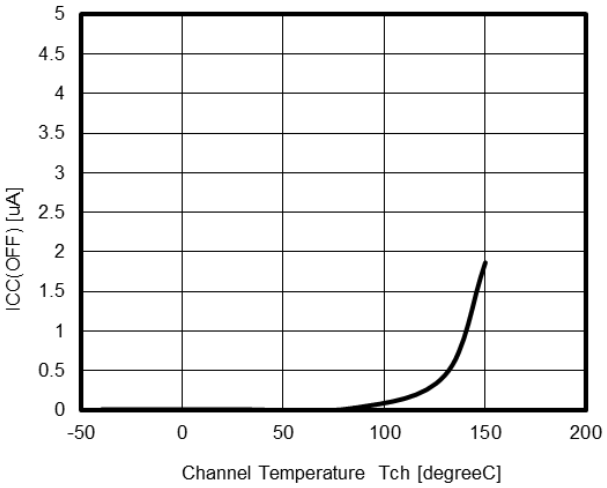
Operating current per channel
VS. Channel TEMPERATURE



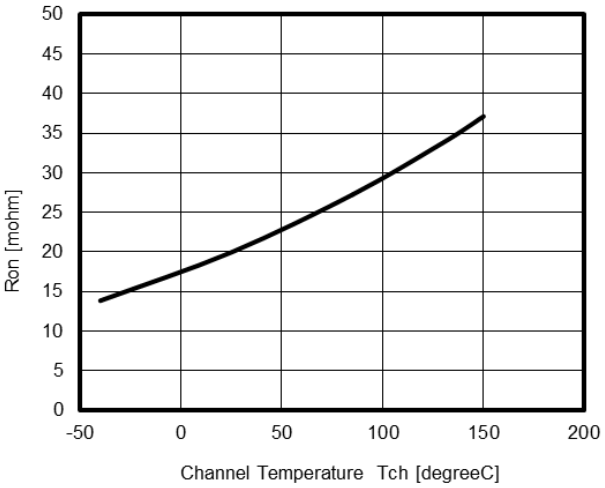
Output Leakage current per channel
VS. Channel TEMPERATURE



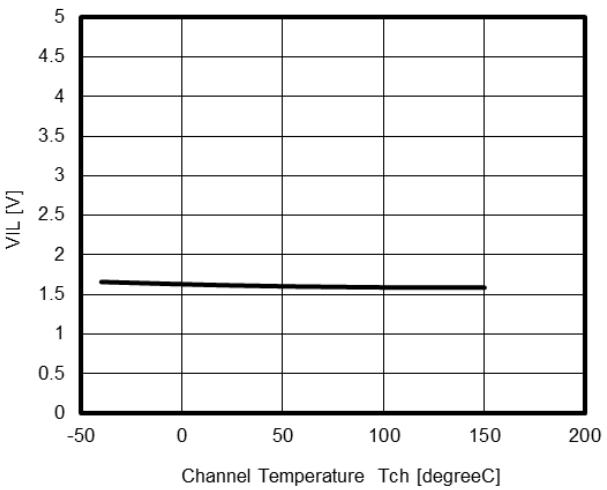
Standby current
VS. Channel TEMPERATURE



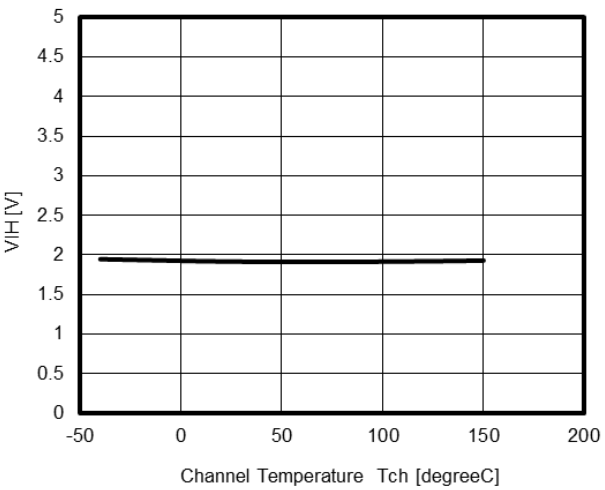
On-state resistance per channel
VS. Channel TEMPERATURE



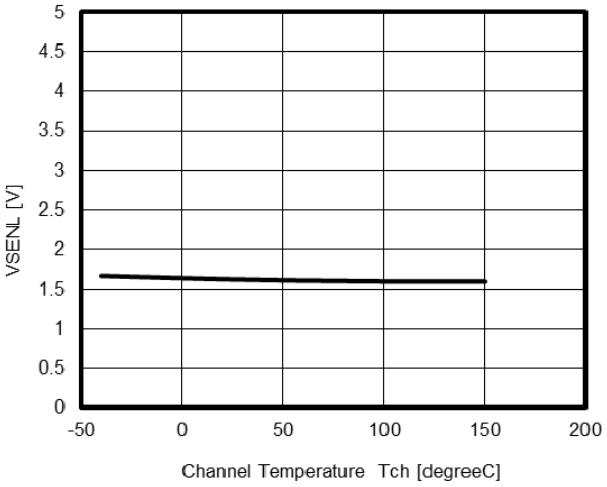
Low level IN pin voltage
VS. Channel TEMPERATURE



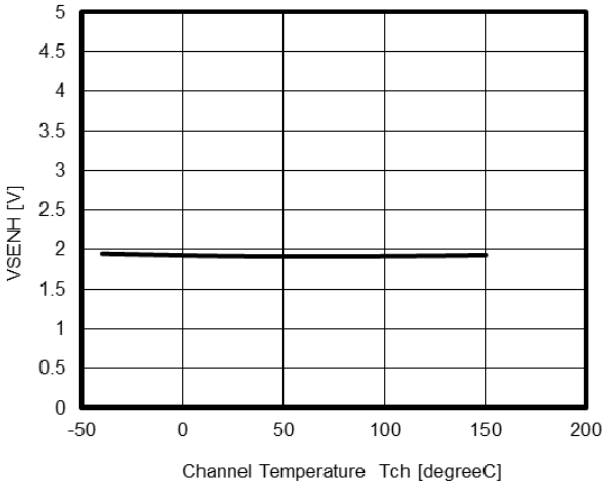
High level IN pin voltage
VS. Channel TEMPERATURE



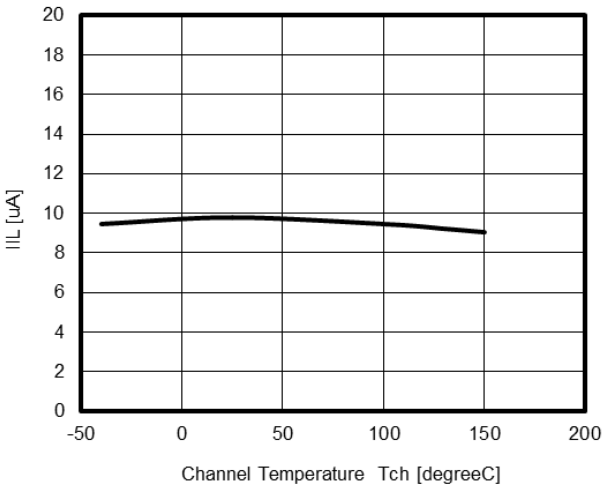
Low level SEN pin voltage
VS. Channel TEMPERATURE



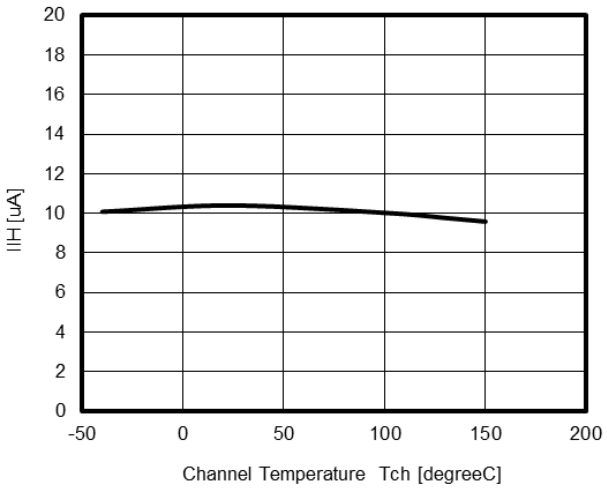
High level SEN pin voltage
VS. Channel TEMPERATURE



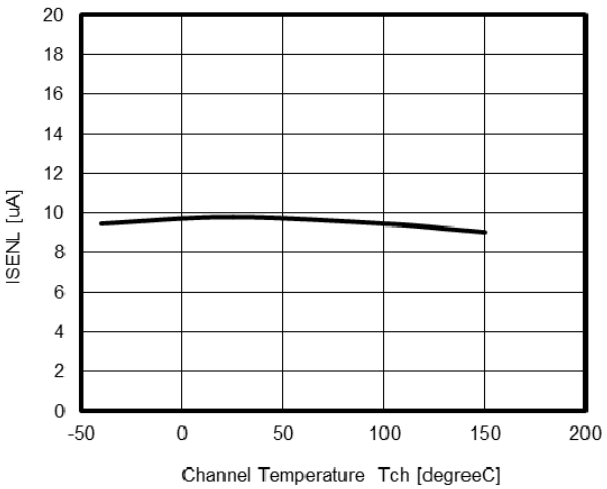
Low level IN pin current
VS. Channel TEMPERATURE



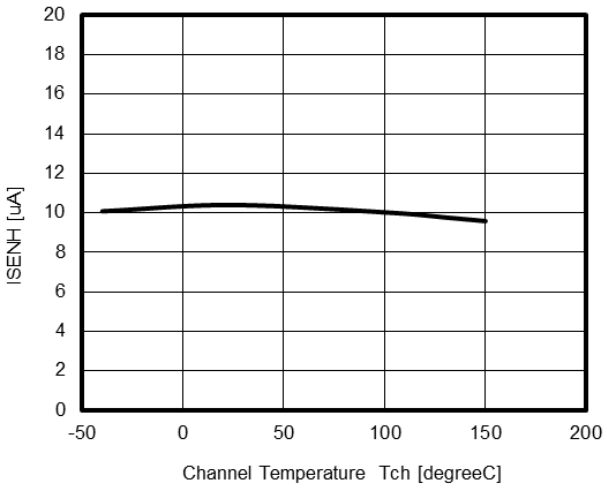
HIgh level IN pin current
VS. Channel TEMPERATURE



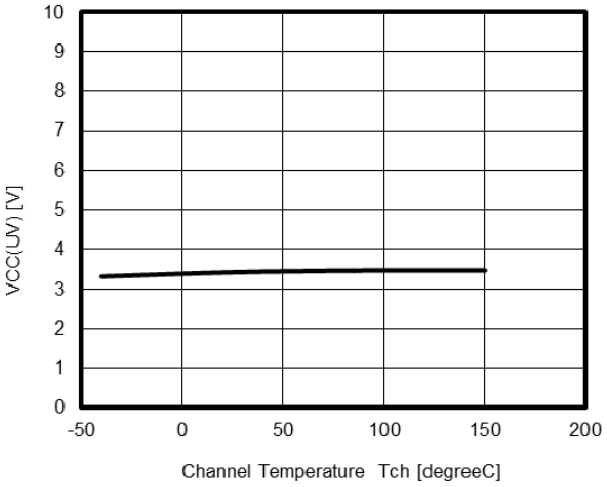
Low level SEN pin current
VS. Channel TEMPERATURE



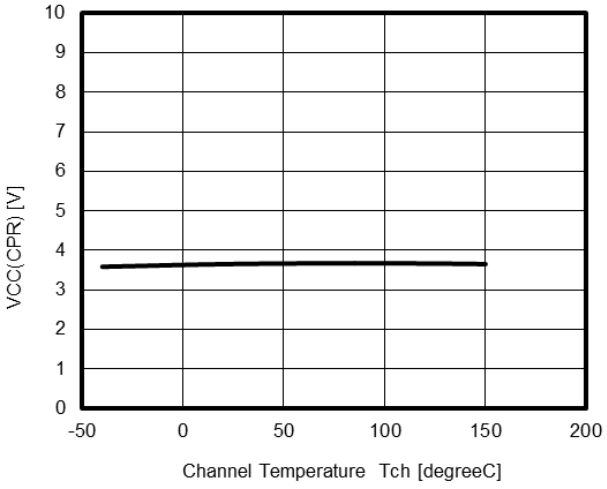
HIgh level SEN pin current
VS. Channel TEMPERATURE



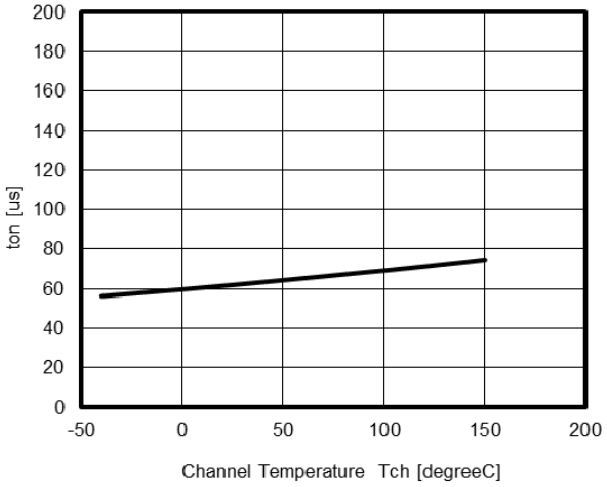
Under voltage shutdown
VS. Channel TEMPERATURE



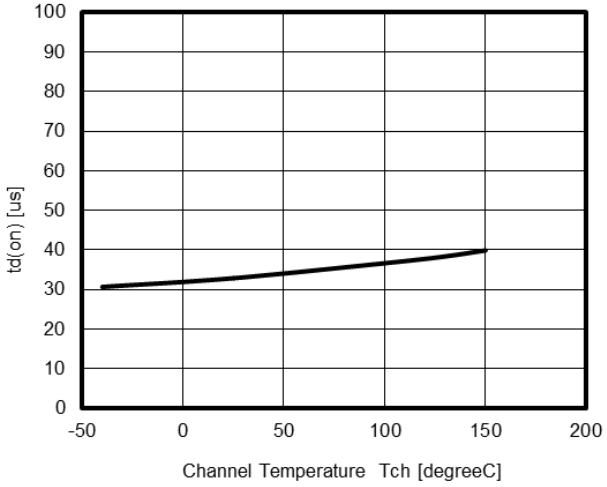
Under voltage restart
VS. Channel TEMPERATURE



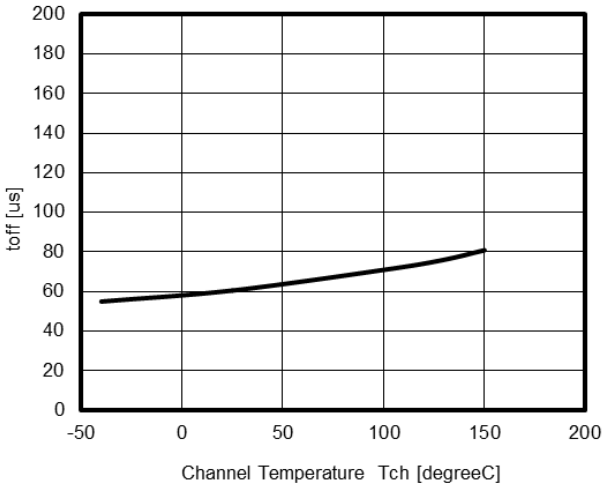
Turn on time
VS. Channel TEMPERATURE



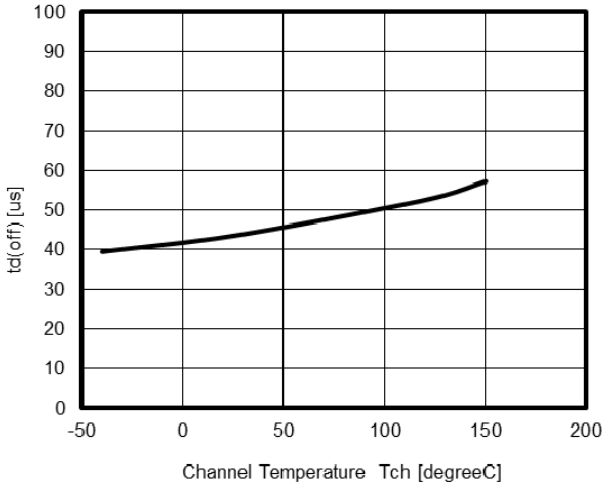
Turn on delay time
VS. Channel TEMPERATURE



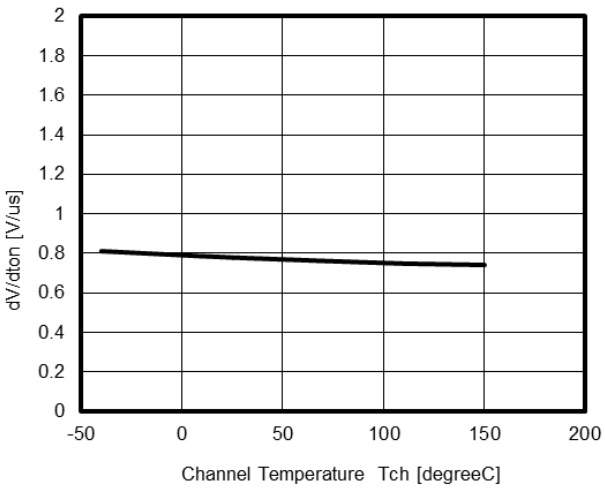
Turn off time
VS. Channel TEMPERATURE



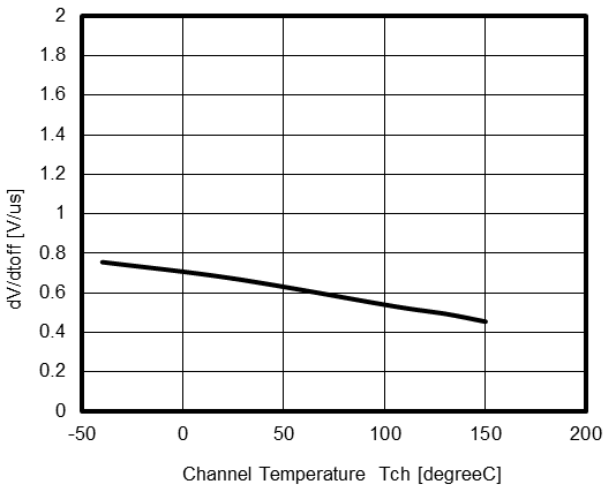
Turn off delay time
VS. Channel TEMPERATURE



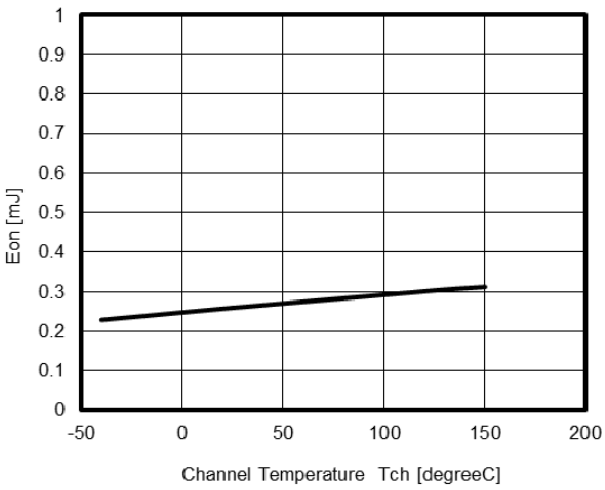
Slew rate on
VS. Channel TEMPERATURE



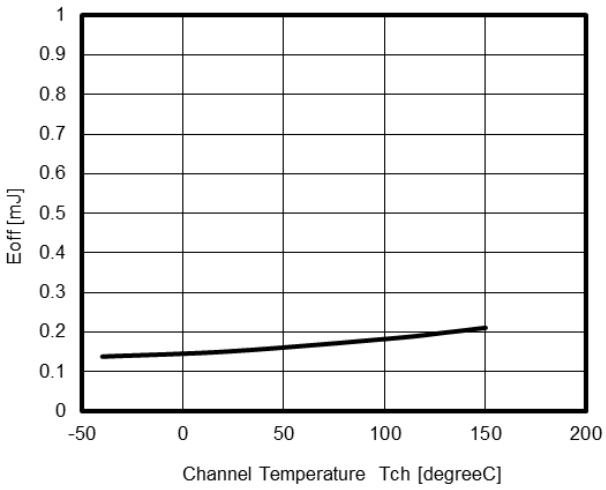
Slew rate off
VS. Channel TEMPERATURE



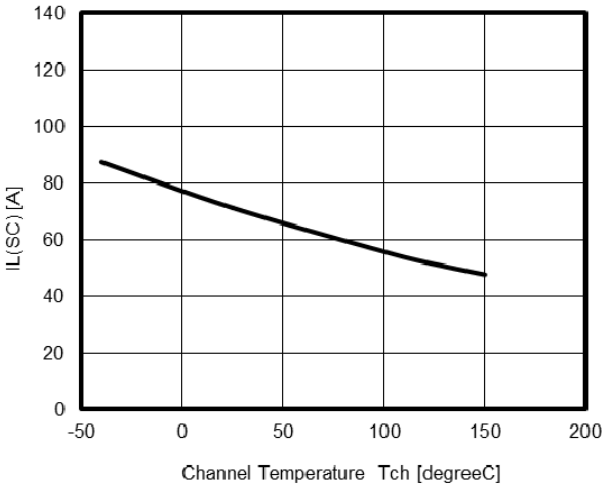
Turn on energy loss
VS. Channel TEMPERATURE



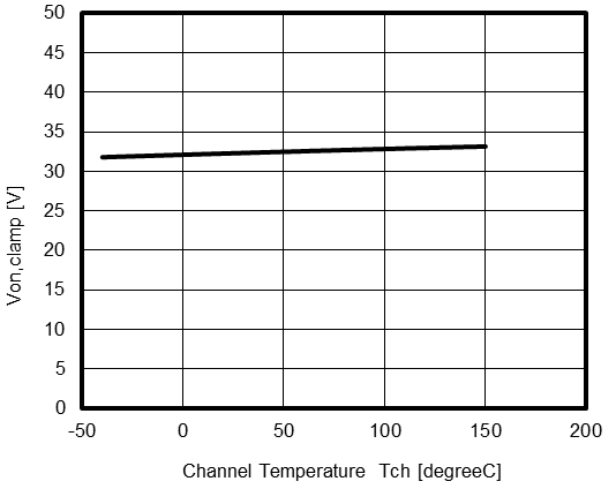
Turn off energy loss
VS. Channel TEMPERATURE



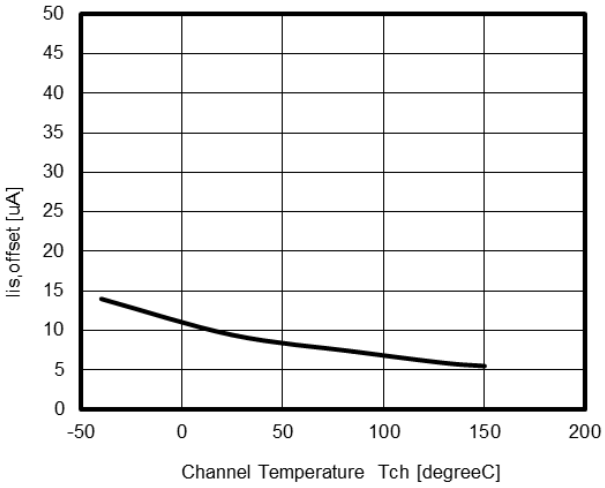
Over current detection current
VS. Channel TEMPERATURE



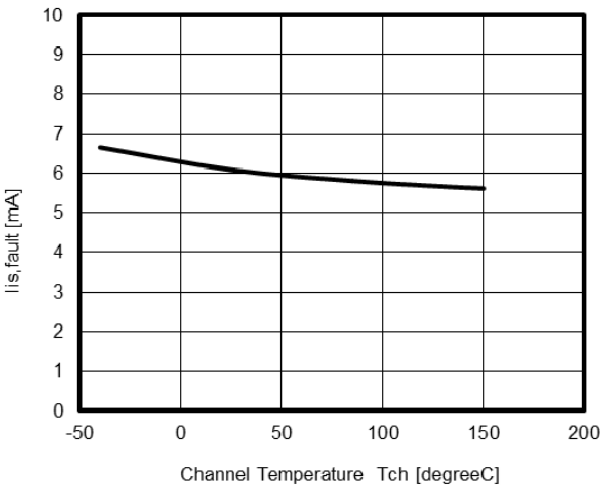
Output clamp at inductive load switch off
VS. Channel TEMPERATURE



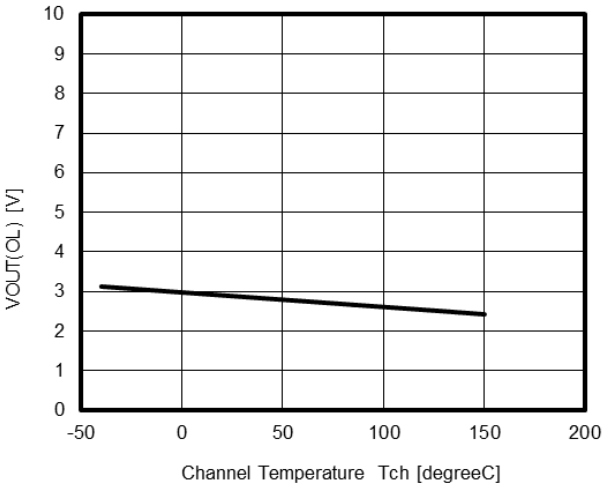
Senese current offset current
VS. Channel TEMPERATURE



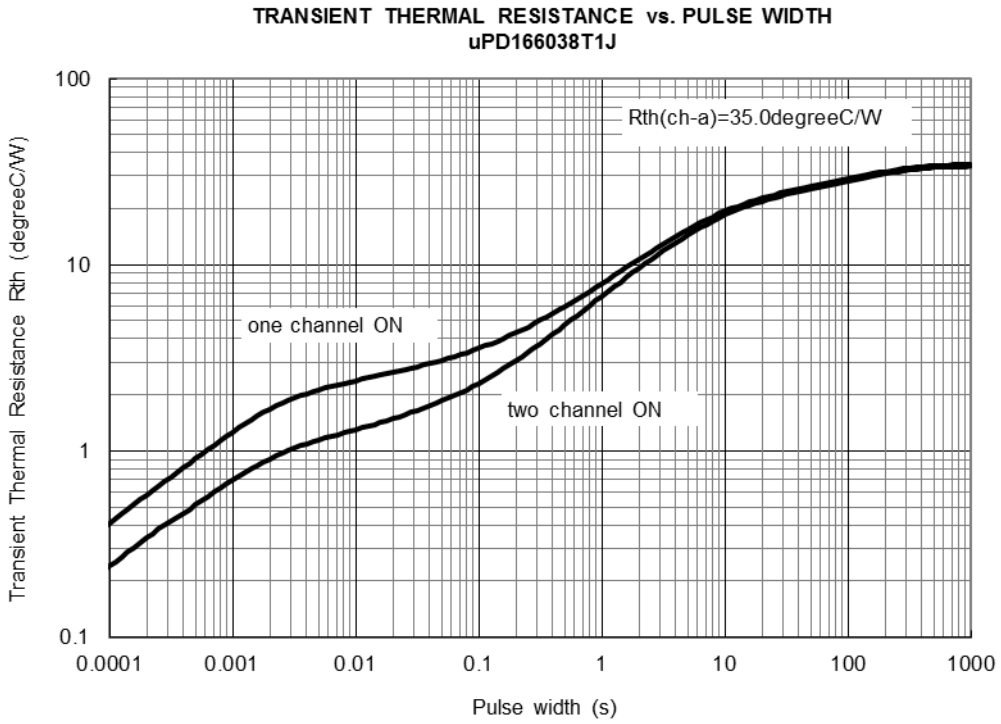
Sense current under fault condition
VS. Channel TEMPERATURE



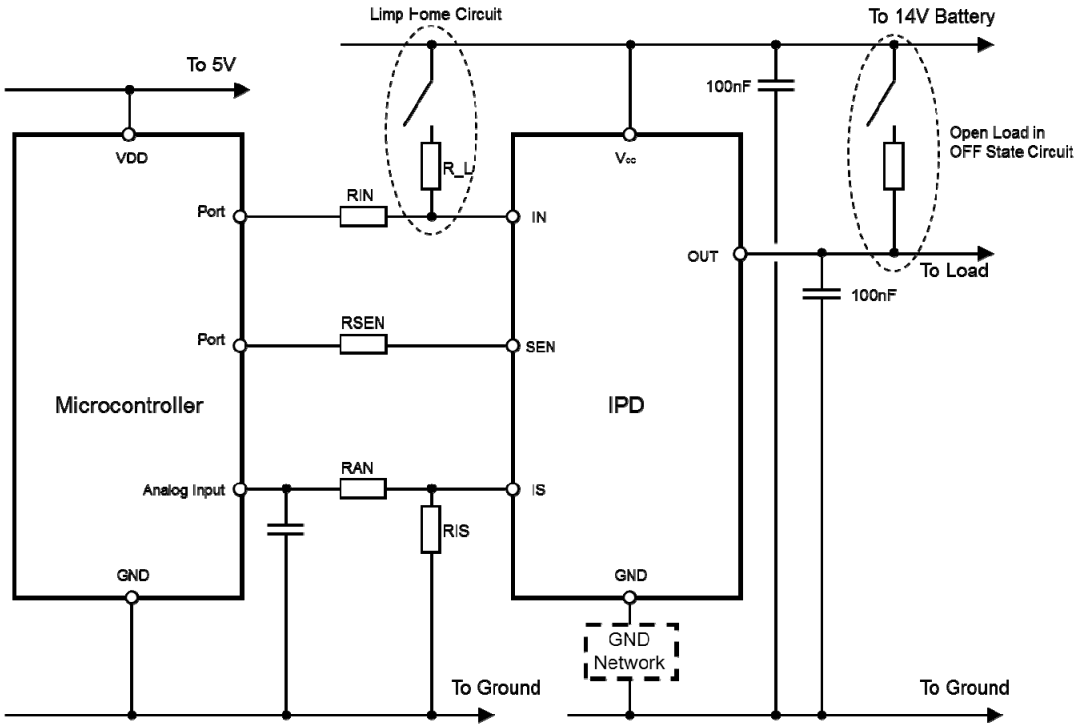
Open load detection threshold at off-state
VS. Channel TEMPERATURE



5. Thermal characteristics



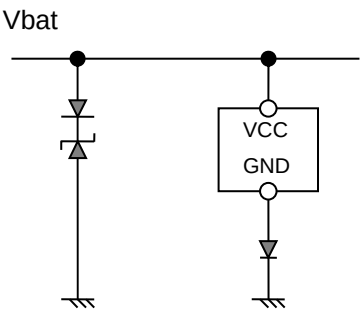
6. Application example in principle



RIN, RSEN, RAN values are in range of 2k to 50kohm depending microcontroller while R_L value is typically 4kohm. If necessary to raise HBM tolerated dose, adding resister between OUT terminal and Ground is effective. Resister's value is typically 100kohm

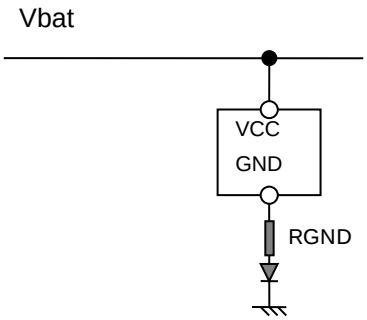
GND Network recommendation

In case of V_loaddump < 35V



External diode is recommended in order to prevent reverse current toward control logic part at reverse battery condition.

In case of 35V < V_loaddump < 42V



External diode and resistor are recommended in order to prevent reverse current toward control logic part at reverse battery condition and limit the current through ZD_{AZ} at load dump condition. 100ohm is recommended as RGND.

Note: If other component is installed to prevent reverse current at reverse battery condition, diode is not required in GND Network.

Note: Approx. 10kohm additional resistor in parallel with diode is recommended depends on Vf- If performance of the diode.

Revision History	μPD166038T1J Datasheet

Rev.	Date	Description	
		Page	Summary
1.00	Sep. 17, 2013	1-38	1st issue
2.00	May 22, 2015	15	"Device behavior at reverse current conduction during on-state" is added.
2.01	Jul. 01, 2015	16-23	Von(NL) is deleted from State transition diagram.

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